K.S.INSTITUTE OF TECHNOLOGY, BANGALORE

(AFFLIATED TO VISVESVARAYA TECHNOLOGICAL UNIVERSITY, BELGAUM) DEPARTMENT OF ELECTRONICS & COMMUNICATION ENGG.

Engineering Statistics and Linear Algebra IV (Common to all Branches)

Course Title: COMPLEX ANALYSIS, PROBABILITY&STATISTICAL METHODS

Credits:03 Contact Hours/Week: 04 Exam. Marks:100 Exam. Hours : 03 Code : 18MAT41 L-T-P :2-2-0 Total Hours:50 IA Marks :30

Course Learning Objectives: This course will enable students to:

- Understand and Analyze Single and Multiple Random Variables, and their extension to Random Processes.
- Familiarization with the concept of Vector spaces and orthogonality with a qualitative insight into applications incommunications.
- Compute the quantitative parameters for functions of single and Multiple Random Variables and Processes.
- Compute the quantitative parameters for Matrices and LinearTransformations.

Module-1

Calculus of complex functions: Review of function of a complex variable, limits, continuity, and differentiability. Analytic functions: Cauchy-Riemann equations in Cartesian and polar forms and consequences.

Construction of analytic functions: Milne-Thomson method-Problems.

Module-2

Conformal transformations: Introduction. Discussion of transformations: $w = Z^2$, $w = e^z$, w = z + 1, ($z \neq 0$).Bilinear transformations- Problems.

Complex integration: Line integral of a complex function-Cauchy's theorem and Cauchy's integral formula and problems.

Module-3

Probability Distributions: Review of basic probability theory. Random variables (discrete and continuous), probability mass/density functions. Binomial, Poisson, exponential and normal distributions- problems (No derivation for mean and standard deviation)-Illustrative examples.

Module-4

Statistical Methods: Correlation and regression-Karl Pearson's coefficient of correlation and rank correlation -problems. Regression analysis- lines of regression –problems.

Curve Fitting: Curve fitting by the method of least squares- fitting the curves of the form-

y = ax + b, $y = ax^b and y = ax^2 + bx + c$.

Module-5

Joint probability distribution: Joint Probability distribution for two discrete random variables, expectation and covariance.

Sampling Theory: Introduction to sampling distributions, standard error, Type-I and Type-II errors. Test of hypothesis for means, student's t-distribution, Chi-square distribution as a test of goodness of fit.

Course Outcomes:

At the end of the course the student will be able to:

- Use the concepts of analytic function and complex potentials to solve the problems arising in electromagnetic field theory.
- Utilize conformal transformation and complex integral arising in aerofoil theory, fluid flow visualization and image processing.
- Apply discrete and continuous probability distributions in analyzing the probability models arising in engineering field.
- Make use of the correlation and regression analysis to fit a suitable mathematical model for the statistical data.
- Construct joint probability distributions and demonstrate the validity of testing the hypothesis.

Question paper pattern:

- 5. The question paper will have ten full questions carrying equal marks.
- 6. Each full question will be for 20 marks.
- There will be two full questions (with a maximum of four sub- questions) from each module.

Sl. No.	Title of the Book	Name of the	Name of the	Edition and Year
		Author/s	Publisher	
Textboo	oks		·	
1	Advanced Engineering Mathematics	E. Kreyszig	John Wiley & Sons	10 th Edition,2016
2	Higher Engineering Mathematics	B. S. Grewal	Khanna Publishers	44 th Edition, 2017
3	Engineering Mathematics	Srimanta Pal et al	Oxford University Press	3 rd Edition,2016
Referen	ce Books			
1	Advanced Engineering Mathematics	C. Ray Wylie, Louis C.Barrett	McGraw-Hill	6 th Edition 1995
2	Introductory Methods of Numerical Analysis	S.S.Sastry	Prentice Hall of India	4 th Edition 2010
3	Higher Engineering Mathematics	B. V. Ramana	McGraw-Hill	11 th Edition,2010
4	A Text Book of Engineering Mathematics	N. P. Bali and Manish Goyal	Laxmi Publications	2014
Web lin	ks and Video Lectures:			•
1. http:/	/nptel.ac.in/courses.php?disciplin	eID=111		
2. http:/	//www.class-central.com/subject/n	nath(MOOCs)		
3. http:/	//academicearth.org/			

4. VTU EDUSAT PROGRAMME - 20

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – IV

	ANALOG CIRCUITS		
Subject Code	18EC42	CIE Marks	40
Number of Lecture Hours/Week	3+2 (Tutorial)	SEE Marks	60
		Exam Hours	03
	CREDITS – 04		

Course Learning Objectives: This course will enable students to:

- Explain various BJT parameters, connections and configurations.
- Design and demonstrate the diode circuits and transistoramplifiers.
- Explain various types of FET biasing, and demonstrate the use of FET amplifiers.
- Construct frequency response of FET amplifiers at various frequencies.
- Analyze Power amplifier circuits in different modes of operation.
- Construct Feedback and Oscillator circuits usingFET.

Construct recuback and Osemator encurts using E1.	1
Modules	RBT Level
Module -1	1
BJT Biasing: Biasing in BJT amplifier circuits: The Classical Discrete circuit bias (Voltage-	
divider bias), Biasing using a collector to base feedback resistor.	
Small signal operation and Models: Collector current and transconductance, Base current and	
input resistance, Emitter current and input resistance, voltage gain, Separating the signal and the	
DC quantities, The hybrid Π model.	
$\label{eq:moster} \textbf{MOSFETs:} Biasing in \textbf{MOSamplifiercircuits:} Fixing V_{GS}, Fixing V_G, Drainto Gatefeed back$	L1, L2,L3
resistor. Small signal analysism and modeling. The DC bies point signal surrent in drain, welfage gain.	
Small signal operation and modeling: The DC bias point, signal current in drain, voltage gain,	
small signal equivalent circuit models, transconductance. $IT_{avt} = 1, 25(351, 353), 36(361, to 366), 45(451, 453, 453), 46(461, to 466)$	
[Text 1: 3.5(3.5.1, 3.5.3), 3.6(3.6.1 to 3.6.6), 4.5(4.5.1, 4.5.2, 4.5.3), 4.6(4.6.1 to 4.6.6)] Module -2	
MOUTE -2 MOSFET Amplifier configuration: Basic configurations, characterizing amplifiers, CS	
amplifier with and without source resistance R_{s} . Source follower.	
MOSFET internal capacitances and High frequency model: The gate capacitive effect,	
Junction capacitances, High frequency model.	
Frequency response of the CS amplifier : The three frequency bands, high frequency response,	L1, L2, L3
Low frequency response.	L1, L2, L3
Oscillators: FET based Phase shift oscillator, LC and Crystal Oscillators (no derivation)	
Text 1: 4.7(4.7.1 to 4.7.4, 4.7.6) 4.8(4.8.1, 4.8.2, 4.8.3), 4.9, 12.2.2, 12.3.1, 12,3,2]	
Module -3	
Feedback Amplifier: General feedback structure, Properties of negative feedback, The Four	
Basic Feedback Topologies, The series-shunt, series-series, shunt-shunt and shunt-series	
amplifiers (Qualitative Analysis).	
Output Stages and Power Amplifiers: Introduction, Classification of output stages,, Class A	
output stage, Class B output stage: Transfer Characteristics, Power Dissipation, Power	L1, L2, L3
Conversion efficiency, Class AB output stage, Class C tuned Amplifier.	
[Text 1: 7.1, 7.2, 7.3, 7.4.1, 7.5.1, 7.6 (7.6.1 to 7.6.3), 13.1, 13.2, 13.3(13.3.1, 13.3.2, 13.3.3,	
13.4, 13.7)]	
Module -4	
Op-Amp with Negative Feedback and general applications	
Inverting and Non inverting Amplifiers – Closed Loop voltage gain, Input impedance, Output	
impedance, Bandwidth with feedback. DC and AC Amplifiers, Summing, Scaling and Averaging	1112 12
Amplifiers, Instrumentation amplifier, Comparators, Zero Crossing Detector, Schmitt trigger.	L1,L2, L3
[Text 2: 3.3(3.3.1 to 3.3.6), 3.4(3.4.1 to 3.4.5) 6.2, 6.5, 6.6 (6.6.1), 8.2, 8.3, 8.4]	
Module -5	1

Op-Amp Circuits : DAC - Weighted resistor and R-2R ladder, ADC- Successive approximation	
type, Small Signal half wave rectifier, Active Filters, First and second order low-pass and high-	
pass Butterworth filters, Band-pass filters, Band reject filters.	
555 Timer and its applications: Monostable and a stable Multivibrators.	L1, L2, L3
[Text 2: 8.11(8.11.1a, 8.11.1b), 8.11.2a, 8.12.2, 7.2, 7.3, 7.4, 7.5, 7.6, 7.8, 7.9, 9.4.1, 9.4.1(a),	
9.4.3, 9.4.3(a)]	
Course Outcomes: At the end of this course students will demonstrate the ability to	
• Identify the performance characteristics and parameters of BJT and FET amplifier using small	signal model.
• Design and Analyze the MOSFET amplifier and Oscillator circuits.	
Design and Analyze the BJT power amplifier.	
Identify the functioning and application of linear ICs.	
• Design of Linear IC based circuits Like DAC, ADC, Rectifier and Filters.	
Question paper pattern:	
• Examination will be conducted for 100 marks with question paper containing 10 full quest	ions, each of 20
marks.	
• Each full question can have a maximum of 4 subquestions.	
• Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthe module.	
• Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.	
• Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.	
Text Books:	
1. MicroelectronicCircuits, Theory and Applications, AdelSSedra, KennethCSmith, 6 th Edition, O	xford,
2015.ISBN:978-0-19-808913-1	
 Op-AmpsandLinearIntegratedCircuits,RamakantAGayakwad,4thEdition.PearsonEducation ISBN:8120320581 	,2000.
Reference Books:	
1. ElectronicDevicesandCircuitTheory,RobertLBoylestadandLouisNashelsky,11 th Edition,Pear	son
Education, 2013, ISBN:978-93-325-4260-0.	01 065 7125
2. Fundamentals of Microelectronics, BehzadRazavi, 2 nd Edition, John Weily, 2015, ISBN 978	
3. J.Millman&C.C.Halkias—IntegratedElectronics,2 nd edition,2010,TMH.ISBN0-07-462245-5)

https://nptel.ac.in/courses/117/101/117101106/
 https://www.classcentral.com/course/swayam-analog-electronic-circuit-13894

ChoiceBasedCreditSyste	B. E. (EC / TC) em(CBCS)andOutcomeBased	Education(OBE)	
	SEMESTER -III		
Course Code	CONTROL SYSTEMS 18EC43	CIE Marks	40
Number of Lecture Hours/Week	3	SEE Marks	60
Total Number of Lecture Hours	40 (08 Hours per Module)	Exam Hours	03
	CREDITS – 03		
 Course Learning Objectives: This course Understand the basic features, configuration Understand various terminologies Learn how to find a mathematical response from the transfer function via Mason Analyze the stability of a system from the transfer function of the transfer function for the transfer function via Mason 	figurations and application o and definitions for the contro- nodel of electrical, mechanic om the transferfunction. on s'rule.	olsystems.	anical
5 5 5	Modules		RBT Level
	Module – 1		
Introduction to Control Systems: Type s, Differential equation of Physical Sys Electromechanical systems, Analogous Systems	tems –Mechanical Systems, E ystems.	•	L1, L2, L3
	Module – 2		1
Block diagrams and signal flow graphs: ignal Flow graphs.	Transfer functions, Block diag	ram algebra and	L1, L2, L3
	Module – 3		I
Time Response of feedback control syst First and Second order Systems. T specifications of second order system Introduction to PI, PD and PID Controller	ime response specifications, ns, steady state errors and	Time response	L1, L2, L3
	Module – 4		
Stability analysis: Concepts of stability, N riterion, Relative stability analysis: more ntroduction to Root-Locus Techniques, Th Frequency domain analysis and stabilit response, Bode Plots, Experimental determentation	on the Routh stability criterion. he root locus concepts, Constru y: Correlation between time an	ction of rootloci.	L1, L2, L3
	Module – 5		L
Introduction to Polar Plots, (Inv preliminaries, Nyquist Stability crit excluded) Introduction to lead, lag and lead- lag con Introduction to State variable analysis: for electrical systems, Solution of state eq	ppensating networks (excluding Concepts of state, state variabl	nsportation lag g design).	L1, L2, L3

Course Outcomes: At the end of the course, the students will be able to

- Develop the mathematical model of mechanical / electrical systems and obtain its transfer function using block reduction method /Signal flow graph method
- Ability to relate transient performance parameters (overshoot, rise time, peak time and settling time) for the given system and to evaluate steady state error.
- Identify various stability criteria and Determine the stability of a system in the time domain using Routh-Hurwitz criterion and Root-locus technique.
- Determine the stability of a system in the frequency domain using Nyquist and bode plots
- Develop a control system model in continuous and discrete time using state variable techniques

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

J. Nagarath an d M.Gopal, "Control System s Engineering", New Age International(P) Limited, Publishers, Fifthedition- 2005,ISBN: 81 - 224 - 2008-7.

Reference Books:

- "Modern Control Engineering," K.Ogata, Pearson Education Asia/ PHI,4th dition,2002. ISBN 978 - 81 - 203 - 4010 - 7.
 - 2. "Automatic Control Systems", BenjaminC. Kuo, JohnWileyIndia Pvt. Ltd., 8th dition, 2008.
 - 3. "Feedback and Control System," Joseph J Distefano III et al., Schaum'sOutlines, TMH, 2ⁿ d Edition2007.

Web Link and Video Lectures:

- 1. https://www.edx.org/course/introduction-to-control-system-design-a-first-look
- 2. https://www.classcentral.com/course/swayam-control-systems-13963
- 3. https://swayam.gov.in/nd1_noc19_de04/preview

B. E. (EC / TC)
Choice Based Credit System (CBCS) and Outcome Based Education (OBE)
SEMESTER – IV

ENGINEERING STA	TISTICS and LINEAR ALGEE	BRA		
Course Code	18EC44	CIE Mar	·ks	40
Number of Lecture Hours/Week	03	SEE Marks Exam Hours		60
Total Number of Lecture Hours	40 (8 Hours per Module)			03
	CREDITS – 03			
 Course Learning Objectives: This course will Understand and Analyze Single and M Processes. Familiarization with the concept of Ve applications incommunications. Compute the quantitative parameters for Processes. Compute the quantitative parameters for Modu 	fultiple Random Variables, and the octor spaces and orthogonality with or functions of single and Multiple or Matrices and LinearTransformation	h a qualitativ e Random Va	e insig ariable	ht into
		di stuile sti su	KD I	Level
Single Random Variables: Definition of random variables, cumulative distribution function continuous and discrete random variables; probability mass function, probability density functions and properties; Expectations, Characteristic functions, Functions of single Random Variables, Conditioned Random variables. Application exercises to Some special distributions:Uniform,Exponential,Laplace,Gaussian;Binomial,andPoissondistribution. (Chapter 4 Text 1)				
	Module -2			
Multiple Random variables: Concept, Two variable CDF and PDF, Two Variable expectations (Correlation, orthogonality, Independent), Two variable transformation, Two Gaussian Random variables, Sum of two independent Random Variables, Sum of IID Random Variables – Central limit Theorem and law of large numbers, Conditional joint Probabilities, ApplicationexercisestoChi-squareRV, Student-TRV, CauchyandRayleigh RVs. (Chapter 5 Text1)			L1, I	.2, L3
	Module-3			
RandomProcesses: Ensemble,PDF,Independer Functions (ACF, CCF, Addition, and Multipl Spectral Densities (Wiener Khinchin, Addition densities), Linear Systems (output Mean, Cro and output), Exercises with Noise. (Chapter 6)	ication), Ergodic Random Proces on and Multiplication of RPs, Cruss correlation and Auto correlati	sses, Power oss spectral	L1, I	.2, L3
	Module -4			
Vector Spaces: Vector spaces and Null subspaces, Rank and Row reduced form, Independence, Basis and dimension, Dimensions of the four subspaces, Rank-Nullity Theorem, Linear Transformations Orthogonality: Orthogonal Vectors and Subspaces, Projections and Least squares, OrthogonalBasesandGram-SchmidtOrthogonalizationprocedure.(ReferChapters2and 3 Text2)				.2, L3
	Module -5			
Determinants: Properties of Determinants, Per Text 2) Eigenvalues and Eigen vectors: Review of E Special Matrices (Positive Definite, Symmetric Decomposition. (Refer Chapter 5, Text 2)	igenvalues and Diagonalization of	f a Matrix,	L1, I	.2, L3

Course Outcomes: After studying this course, students will be able to:

- Identify Random Variables to extract quantitative statistical parameters and apply the same for special distributions.
- Analyze statistical representations and Eigen values of some special matrices and demonstrate the same using MATLAB.
- Analyze Random events in typical communication events to extract quantitative statistical parameters.
- Analyze vectors and vector spaces using suitable transformations and basis function sets.
- Analyze the concept of Multiple Random variables to extract quantitative statistical parameters.

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthe module.
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Books:

- 1. Richard H Williams, "Probability, Statistics and Random Processes for Engineers" Cengage Learning, 1st Edition, 2003, ISBN 13: 978-0-534- 36888-3, ISBN 10:0-534-36888-3.
- 2. GilbertStrang, "LinearAlgebraanditsApplications", CengageLearning, 4thEdition, 2006, ISBN 97809802327

Reference Books:

- 1. Hwei P. Hsu, "Theory and Problems of Probability, Random Variables, and Random Processes" Schaums Outline Series, McGraw Hill. ISBN 10: 0-07-030644-3.
- 2. K. N. HariBhat, K Anitha Sheela, Jayant Ganguly, "Probability Theory and Stochastic Processes for Engineers", Cengage Learning India, 2019, ISBN: Not inbook

Web Link and Video Lectures:

1. www.coursera.org/courses?query=linear%20algebra

2. www.classcentral.com/course/matrix-algebra-engineers-11986

B. E. (EC / TC) $ChoiceBasedCreditSystem (CBCS) and OutcomeBasedEducation (OBE) \ SEMESTER-$

IV

SIGNALS AND SYSTEMS				
Course Code	18EC45	CIE Marks	40	
Number of Lecture Hours/Week	03	SEE Marks	60	
Total Number of Lecture Hours	40 (8 Hours per Module)	Exam Hours	03	
CREDITS – 03				

Course Learning Objectives: This course will enable students to:

systems.

- Understand the mathematical description of continuous and discrete time signals and systems.٠
- Analyze the signals in time domain using convolution sum andIntegral. •
- Classify signals into different categories based on theirproperties. •
- Analyze Linear Time Invariant (LTI) systems in time and transformdomains. •

Module-1	RBT Level
Introduction and Classification of signals: Definition of signal and systems, communication and control system as examples Classification of signals. Basic Operations on signals: Amplitude scaling, addition, multiplication, differentiation, integration, time scaling, time shift and time reversal. Elementary signals/Functions: Exponential, sinusoidal, step, impulse and ramp functions. Expression of triangular, rectangular and other waveforms in terms of elementary signals.	L1, L2, L3
Module -2	
System Classification and properties: Linear-nonlinear, Time variant-invariant, causal- noncausal, static-dynamic, stable-unstable, invertible. Time domain representation of LTI System: Impulse response, convolution sum, convolution integral. Computation of convolution sum and convolution integral using graphical method for unit step and unit step, unit step and exponential, exponential and exponential, unit step and rectangular, and rectangular and rectangular.	L1, L2, L3
Module-3	
LTI system Properties in terms of impulse response: System interconnection, Memory less, Causal, Stable, Invertible and Deconvolution, and step response. Fourier Representation of Periodic Signals : CTF Sproperties and basic problems.	L1, L2, L3
Module -4	
 Fourier Representation of aperiodic Signals: Introduction to Fourier Transform & DTFT, Definition and basic problems. Properties of Fourier Transform: Linearity, Time shift, Frequency shift, Scaling, Differentiation and Integration, Convolution and Modulation, Parseval's theorem and problems on properties of Fourier Transform. 	L1, L2, L3
Module -5	
The Z-Transforms : Z transform, properties of the region of convergence, properties of the Z-transform, Inverse Z-transform, Causality and stability, Transform analysis of LTI systems.	L1, L2, L3
 Course Outcomes: At the end of the course, students will be able to: Apply the basic operations on signals and classify elementary signals. Classify the various systems and analyze the concepts of convolution sum & integral on signals and represent periodic continuous/discrete signals in time a domain using Fourier series. Make use of the properties of Fourier Transform on aperiodic signals to represent the signa frequency domain. Make use of Z-transforms, inverse Z-transforms and transfer functions to analyze the comparison of the compa	nd frequency als in

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad The rewill be 2 full questions from each module covering all the topics of the module.$
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

Simon Haykins and Barry Van Veen, "Signals and Systems", 2nd Edition, 2008, Wiley India. ISBN 9971-51-239-4.

Reference Books:

- 1. **MichaelRoberts**, "FundamentalsofSignals&Systems", 2ndedition, TataMcGraw-Hill, 2010, ISBN 978-0-07-070221-9.
- 2. AlanVOppenheim, AlanS, Willsky and AHamidNawab, "Signals and Systems" Pearson Education Asia / PHI, 2nd edition, 1997. Indian Reprint 2002.
- 3. H.P Hsu, R. Ranjan, "Signals and Systems", Scham's outlines, TMH,2006.
- 4. **B.P.Lathi**, "LinearSystemsandSignals", OxfordUniversityPress, 2005.
- 5. GaneshRaoandSatishTunga, "SignalsandSystems", Pearson/Sanguine.

Web Link and Video Lectures:

1. www.edx.org/course/signals-and-systems-part-1

2. www.classcentral.com/course/swayam-principles-of-signals-and-systems-9900

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – IV

MICROCONTROLLER					
Course Code18EC46CIE Marks40					
Number of Lecture Hours/Week	03	SEE Marks	60		
Total Number of Lecture Hours	40 (8 Hours per Module)	Exam Hours	03		
CREDITS – 03					

Course Learning Objectives: This course will enable students to:

- UnderstandthedifferencebetweenaMicroprocessorandaMicrocontrollerandembedded microcontrollers.
- Familiarize the basic architecture of 8051microcontroller.
- Program 8051microprocessor using Assembly Level Language andC.
- Understand the interrupt system of 8051 and the use of interrupts.
- UnderstandtheoperationanduseofinbuiltTimers/CountersandSerialportof8051.
- Interface 8051 to external memory and I/O devices using its I/Oports.

Module-1	RBT Level
8051 Microcontroller: Microprocessor Vs Microcontroller, Embedded Systems, Embedded Microcontrollers, 8051 Architecture- Registers, Pin diagram, I/O ports functions, Internal Memory organization. External Memory (ROM & RAM) interfacing.	L1, L2
Module -2	
8051 Instruction Set: Addressing Modes, Data Transfer instructions, Arithmetic instructions, Logical instructions, Branch instructions, Bit manipulation instructions. Simple Assembly language program examples (without loops) to use these instructions.	L1, L2
Module-3	
8051 Stack, I/O Port Interfacing and Programming: 8051 Stack, Stack and Subroutine instructions. Assembly language program examples on subroutine and involving loops. Interfacing simple switch and LED to I/O ports to switch on/off LED with respect to switch status.	L1, L2, L3
Module -4	-
8051 Timers and Serial Port: 8051 Timers and Counters – Operation and Assembly languageprogrammingtogenerateapulseusingMode-1andasquarewaveusingMode- 2 on a port pin. 8051 Serial Communication- Basics of Serial Data Communication, RS- 232 standard, 9 pin RS232 signals, Simple Serial Port programming in Assembly and C to transmit a message and to receive dataserially.	L1, L2, L3
Module -5	
8051 Interrupts and Interfacing Applications: 8051 Interrupts. 8051 Assembly language programming to generate an external interrupt using a switch, 8051 C programming to generate a square waveform on a port pin using a Timer interrupt. Interfacing 8051 to ADC-0804, DAC, LCD and Stepper motor and their 8051 Assembly language interfacing programming.	L1, L2, L3
 Course outcomes: At the end of the course, students will be able to: Distinguish the role of functional units in the architecture of 8051 microcontroller Identify various instructions of 8051 Microcontroller Build solutions using assembly level language and high level language Make use of timers/counters, serial port and interrupts to generate delay and perform s Design interfacing of peripherals to 8051 Microcontroller 	erial communication

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad The rewill be 2 full questions from each module covering all the topics of the module.$
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreducedto60marksasSEEmarksis60.

Text Books:

- 1. "The8051MicrocontrollerandEmbeddedSystems-usingassemblyandC",MuhammadAliMazidi andJaniceGillespieMazidiandRollinD.McKinlay;PHI,2006/Pearson,2006.
- 2. "The8051Microcontroller", Kenneth J. Ayala, 3rd Edition, Thomson/CengageLearning.

Reference Books:

- 1. "The8051MicrocontrollerBasedEmbeddedSystems", ManishKPatel, McGrawHill, 2014, ISBN: 978-93-329-0125-4.
- 2. "Microcontrollers: Architecture, Programming, Interfacing and System Design", RajKamal, Pearson Education, 2005.

Web Link and Video Lectures:

- 1. www.edx.org/learn/microcontrollers
- 2. www.nptel.ac.in/courses/108/105/108105102/

B.E. (EC / TC) $Choice Based Credit System (CBCS) and Outcome Based Education (OBE) \\ SEMESTER - \\$ IV MICROCONTROLLER LABORATORY Laboratory Code 18ECL47 40 **CIE Marks 02Hr** Tutorial (Instructions) ofLectureHours/Week **SEE Marks** 60 Number + 02 Hours Laboratory **RBT Levels** L1, L2, L3 Exam Hours 03 **CREDITS – 02** Course Learning Objectives: This laboratory course enables students to Understand the basics of microcontroller and itsapplications. Have in-depth knowledge of 8051 assembly languageprogramming. • • Understand controlling the devices using Cprogramming. The concepts of I/O interfacing for developing real time embeddedsystems. • Laboratory Experiments I. PROGRAMMING 1. DataTransfer:BlockMove,Exchange,Sorting,Findinglargestelementinanarray. 2. Arithmetic Instructions - Addition/subtraction, multiplication and division, square, Cube - (16 bits Arithmetic operations - bitaddressable). 3. Counters. 4. Boolean & Logical Instructions (Bitmanipulations). 5. Conditional CALL & RETURN. 6. Codeconversion:BCD-ASCII;ASCII-Decimal;Decimal-ASCII;HEX-DecimalandDecimal-HEX. 7. Programstogeneratedelay, Programsusingserial portandon-Chiptimer/counter. **II. INTERFACING** 1. Interface a simple toggle switch to 8051 and write an ALP to generate an interrupt which switches on an LED (i) continuously as long as switch is on and (ii) only once for a small time when the switch is turnedon. 2. Write a C program to (i) transmit and (ii) to receive a set of characters serially by interfacing 8051 to a terminal. 3. Write ALPs to generate waveforms using ADCinterface. 4. Write ALP to interface an LCD display and to display a message onit. 5. Write ALP to interface a Stepper Motor to 8051 to rotate themotor. 6. Write ALP to interface ADC-0804 and convert an analog input connected toit. Course Outcomes: On the completion of this laboratory course, the students will be able to:

- Develop Assembly level program for transferring data and to perform arithmetic operations like addition, multiplication etc
- Develop Assembly level program to act as a counter using subroutine
- Make use of timers for generating the delay and serial communication ports for transferring the data serially
- Examine the use of interrupts in controlling the switches connected to the ports
- Test for the working of interface like ADC ,stepper motor, LCD etc

Conduct of Practical Examination:

- All laboratory experiments are to be included for practical examination.
- Students are allowed to pick one experiment from thelot.
- Strictly follow the instructions as printed on the cover page of answer script for breakup ofmarks.
- Change of experiment is allowed only once and 15% Marks allotted to the procedure part to be madezero.

ChoiceBasedCreditSy	B. E. (EC / TC) vstem(CBCS)andOutcomeBasedEduca	tion(OBE) SEMESTE	R –
AN	IV ALOG CIRCUITS LABORATORY		
Laboratory Code	18ECL48	CIE Marks	40
Number of Lecture Hours/Week	02Hr Tutorial (Instructions) + 02 Hours Laboratory	SEE Marks	60
RBT Level	L1, L2, L3	Exam Hours	03
	CREDITS – 02		
frequencyresponseDesign and test of analog circUnderstand the feedback confi	rations and connectivity of BJT and FET		of
Laboratory Experiments			
J	PART A : Hardware Experiments		
1. Design and setup the Common Sou	rce JFET/MOSFET amplifier and plot th	e frequency response.	
2. Design and set up the BJT common gain- bandwidth product, input and	emitter voltage amplifier with and without output impedances.	out feedback and determ	ine the
	itts Oscillator, and ii) Crystal Oscillator		
4. Design active second order Butterw			
5. Design Adder, Integrator and Differ			
6. Test a comparator circuit and design hysteresis.	n a Schmitt trigger for the given UTP and	LTP values and obtain	the
and (ii) by generating digital input		ary input from toggle sv	vitches
8. Design Monostable and a stable Mu	ltivibrator using 555 Timer.		
PART-B : Simulation using EDA so equivalent tool can be used)	ftware (EDWinXP, PSpice, MultiSim, F	roteus, CircuitLab or an	y othe
1. RC Phase shift oscillator and Hartle	ey oscillator		
2. Narrow Band-pass Filter and Narro	w band-reject filter		
3. Precision Half and full wave rectified	er		
4. Monostable and A stable Multivibra	ator using 555 Timer.		
 Design and test the setup of BJT Design and test oscillators by ca Design and analyze the applicati and differentiator circuits. Analyze and test the Multivibrat Analyze and implement the circu and 555 through simulation software 	its of Oscillators, Filters, Rectifiers and M	cy response. t Trigger, and adder, Inte	
• Students are allowed to pick of	e to be included for practicalexamination ne experiment from thelot. sprintedonthecoverpageofanswerscriptfor		

• ChangeofexperimentisallowedonlyonceandMarksallottedtotheprocedureparttobemadezero.

Reference Books:

1. David A Bell, "Fundamentals of Electronic Devices and Circuits Lab Manual, 5th Edition, 2009, Oxford University Press.

B. E. Common to all Programmes ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER -IV

ADDITIONAL MATHEMATICS – II

(Mandatory Learning Course: Common to All Programmes)

(A Bridge course for Lateral Entry students under Diploma quota to BE/B. Tech. programmes)

Course Code	18MATDIP41	CIE Marks	40
Teaching Hours/Week (L:T:P)	(2:1:0)	SEE Marks	60
Credits	0	Exam Hours	03

Course Learning Objectives:

- Toprovideessentialconceptsoflinearalgebra, second&higherorderdifferential equations along with methods to solve them.
- To provide an insight into elementary probability theory and numericalmethods.

Module-1

Linear Algebra: Introduction - rank of matrix by elementary row operations - Echelon form. Consistency of system of linear equations - Gauss elimination method. Eigen values and Eigen vectors of a square matrix. Problems.

Module-2

Numerical Methods: Finite differences. Interpolation/extrapolation using Newton's forward and backward difference formulae (Statements only)-problems. Solution of polynomial and transcendental equations – Newton-Raphson and Regula-Falsi methods (only formulae)- Illustrative examples. Numerical integration: Simpson's one third rule and Weddle's rule (without proof) Problems.

Module-3

Higher order ODE's: Linear differential equations of second and higher order equations with constant coefficients. Homogeneous /non-homogeneous equations. Inverse differential operators.[*Particular Integral restricted to* $R(x) = e^{ax}$, sin ax /cos ax for f(D) = R(x).]

Module-4

Partial Differential Equations (PDE's):- Formation of PDE's by elimination of arbitrary constants and functions. Solution of non-homogeneous PDE by direct integration. Homogeneous PDEs involving derivative with respect to one independent variable only.

Module-5

Probability: Introduction. Sample space and events. Axioms of probability. Addition & multiplication theorems. Conditional probability, Bayes's theorem, problems.

Course Outcomes: At the end of the course the student will be able to:

CO1: Solve systems of linear equations using matrix algebra.

CO2: Apply the knowledge of numerical methods in modelling and solving engineering problems.

CO3: Make use of analytical methods to solve higher order differential equations.

 ${\bf CO4:} Classify partial differential equations and solve them by exact methods.$

CO5: Applyelementaryprobabilitytheoryandsolverelatedproblems.

Question paper pattern:

- 7. The question paper will have ten full questions carrying equalmarks.
- 8. Each full question will be for 20marks.
- Therewillbetwofullquestions(withamaximum offoursub-questions)fromeachmodule.
- Each full question will have sub- question covering all the topics under amodule.
- The students will have to answer five full questions, selecting one full question from each

Sl No	Title of the Book	Name of the Author/s	Name of the Publisher	Edition and Year
Text	book			
1	Higher Engineering Mathematics	B.S. Grewal	Khanna Publishers	43 rd Edition, 2015
Refe	rence Books			

1	Advanced Engineering Mathematics	E. Kreyszig	John Wiley & Sons	10 th Edition, 2015
2	Engineering Mathematics	N. P. Bali and Manish Goyal	Laxmi Publishers	7th Edition, 2007
3	Engineering Mathematics Vol. I	Rohit Khurana	Cengage Learning	1 st Edition, 2015

K.S.INSTITUTE OF TECHNOLOGY, BANGALORE

(AFFLIATED TO VISVESVARAYA TECHNOLOGICAL UNIVERSITY, BELGAUM) DEPARTMENT OF ELECTRONICS & COMMUNICATION ENGG. DIGITAL COMMUNICATION VI

Course Title: DIGITAL COMMUNICATION Credits:03 Contact Hours/Week: 04 Exam. Marks:100 Exam. Hours : 03 Course Code : 18EC61 L-T-P :4-0-0 Total Hours:50 IA Marks :30

Course Learning Objectives: This course will enable students to:	
• Understand the mathematical representation of signal, symbol, and noise.	
• Understand the concept of signal processing of digital data and signal conversion to symbol transmitter and receiver.	ls at the
• Compute performance metrics and parameters for symbol processing and recovery in ideal corrupted channelconditions.	and
• Compute performance parameters and mitigate channel induced impediments in corrupted conditions.	channel
Module-1	RBT Level
Bandpass Signal to Equivalent Low pass: Hilbert Transform, Pre-envelopes, Complex envelopes, Canonical representation of bandpass signals, Complex low pass representation of bandpass systems, Complex representation of band pass signals and systems (Text 1: 2.8, 2.9, 2.10, 2.11, 2.12, 2.13). Line codes: Unipolar, Polar, Bipolar (AMI) and Manchester code and their power spectral densities (Text 1: Ch 6.10). Overview of HDB3, B3ZS, B6ZS (Ref. 1: 7.2)	L1,L2,L3
Module-2	
Signaling over AWGN Channels - Introduction, Geometric representation of signals, Gram- Schmidt Orthogonalization procedure, Conversion of the continuous AWGN channel into a vectorchannel,Optimumreceiversusingcoherentdetection:MLDecoding,Correlationreceiver, matched filter receiver (Text 1: 7.1, 7.2, 7.3,7.4).	L1,L2,L3
Module – 3	
Digital Modulation Techniques : Phase shift Keying techniques using coherent detection: generation, detection and error probabilities of BPSK and QPSK, M–ary PSK, M–ary QAM (Relevant topics in Text 1 of 7.6, 7.7). Frequency shift keying techniques using Coherent detection: BFSK generation, detection and error probability (Relevant topics in Text 1 of 7.8). Non coherent orthogonal modulation techniques: BFSK, DPSK Symbol representation, Block diagrams treatment of Transmitter and Receiver, Probability of error (without derivationof probability of error equation) (Text 1: 7.11, 7.12. 7.13). Module-4	L1,L2,L3
CommunicationthroughBandLimitedChannels : DigitalTransmissionthroughBandlimited channels: Digital PAM Transmission through Band limited Channels, Signal design for Band limited Channels: Design of band limited signals for zero ISI–The Nyquist Criterion (statement only),DesignofbandlimitedsignalswithcontrolledISI-PartialResponsesignals,Probabilityof error for detection of Digital PAM: Probability of error for detection of Digital PAM with Zero ISI,Symbol–by–SymboldetectionofdatawithcontrolledISI(Text2:9.1,9.2,9.3.1,9.3.2). Channel Equalization: Linear Equalizers (ZFE, MMSE), (Text 2: 9.4.2).	L1,L2,L3
Module-5	
Principles of Spread Spectrum: Spread Spectrum Communication Systems: Model of a Spread Spectrum Digital Communication System, Direct Sequence Spread Spectrum Systems, Effect of De-spreading on a narrowband Interference, Probability of error (statement only), Some applications of DS Spread Spectrum Signals, Generation of PN Sequences, Frequency Hopped Spread Spectrum, CDMA based on IS-95 (Text 2: 11.3.1, 11.3.2, 11.3.3, 11.3.4, 11.3.5, 11.4.2).	L1,L2,L3

Course	e Outcomes: At the end of the course, the students will be able to:	
	Develop the concepts of Band pass sampling to well specified signals and channels.	
	Utilize the performance parameters and transfer rates for low pass and bandpass symbol under	
	ideal and corrupted non band limited channels.	
•	Identify valid symbol processing and performance parameters at the receiver under ideal and corrupted bandlimited channels.	
•	Identify the bandpass signals when subjected to corruption and distortion during transmission over a bandlimited channel.	
•	Identify the need for data security using spread spectrum technique and error rate calculation.	
•	Test and validate symbol processing and performance parameters at the receiver under	
	ideal and corrupted bandlimitedchannels.	
•	Demonstrate that bandpass signals subjected to corruption and distortion in a bandlimited	
	channelcanbeprocessed at the receiver to meet specified performance criteria.	
Questi	ion paper pattern:	
•	Examination will be conducted for 100 marks with question paper containing 10 full questions, each other states and the states of the states	of
	20marks.	
•	Each full question can have a maximum of 4 subquestions.	
•	The rewill be 2 full questions from each module covering all the topics of the module.	
•	Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.	
•	Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.	
Text B	Books:	
1.	SimonHaykin, "DigitalCommunicationSystems", JohnWiley&sons, FirstEdition, 2014, ISBN 9764735-5.	78- 0-471-
2.	JohnGProakisandMasoudSalehi, "FundamentalsofCommunicationSystems", 2014Edition, Pea	arson
	Education, ISBN 978-8-131-70573-5.	
Refere	ence Books:	
1.	B.P.LathiandZhiDing, "ModernDigitalandAnalogcommunicationSystems", OxfordUniversit Press, 4 th Edition, 2010, ISBN:978-0-198-07380-2.	У
2.		10,
	ISBN978-0-273-71830-7.	

3. Bernard Sklar and Ray, "Digital Communications - Fundamentals and Applications", Pearson Education, Third Edition, 2014, ISBN:978-81-317-2092-9.

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER -

	EMBEDDED SYSTEMS		
Course Code	18EC62	CIE Marks	40
Number of Lecture Hours/Week	03+2 (Tutorial)	SEE Marks	60
		Exam Hours	03

Course Learning Objectives: This course will enable students to:

• Explain the architectural features and instructions of 32 bit microcontroller-ARMC or tex M3.

• DevelopProgramsusingthevariousinstructionsofARMCortexM3andClanguagefordifferent applications.

- Understandthebasichardwarecomponentsandtheirselectionmethodbasedonthecharacteristicsand attributes of an embeddedsystem.
- Develop the hardware software co-design and firmware designapproaches.
- Explain the need of real time operating system for embedded systemapplications.

Module1	RBT Level
(Text 1: Ch-1, 2, 3)	L1,L2
Module2	
uescribuon. Thumb and ANNI instructions, obeciai instructions, Oserui instructions, Civioio, 1	L1,L2, L3
Module3	
Embedded System Components: Embedded Vs General computing system, Classification of Embedded systems, Major applications and purpose of ES. Elements of an Embedded System (Block diagram and explanation), Differences between RISC and CISC, Harvard and Princeton, Big and LittleEndianformats,Memory(ROMandRAMtypes),Sensors,Actuators, Optocoupler,CommunicationInterfaces(I2C,SPI,IrDA,Bluetooth,Wi-Fi, Zigbeeonly) (Text2:AlltheTopicsfromCh-1andCh-2(Figandexplanationbefore2.1)2.1.1.6to 2.1.1.8,2.2to2.2.2.3,2.3to2.3.2,2.3.3,selectedtopicsof2.4.1and2.4.2only).	L1,L2
Module4	
Embedded System Design Concepts: Characteristics and Quality Attributes of Embedded Systems, Operational and non-operational quality attributes, Embedded Systems-Application and Domain specific, Hardware Software Co-Design and Program Modeling (excluding UML), Embedded firmware design and development (excluding C language). Text 2: Ch-3, Ch-4 (4.1, 4.2.1 and 4.2.2 only), Ch-7 (Sections 7.1, 7.2 only), Ch-9 (Sections 9.1, 9.2, 9.3.1, 9.3.2 only)	L1,L2, L3
Module5	
RTOS and IDE for Embedded System Design: Operating System basics, Types of operating systems, Task, process and threads (Only POSIX Threads with an example program). Thread preemptive Task	L1,L2, L3

Course Outcomes: After studying this course, students will be able to:

- Construct the architectural features and instructions of 32 bit microcontroller ARM Cortex M3.
- Make use of the knowledge gained for Programming ARM Cortex M3 for different applications.
- Identify the basic hardware components and their selection method based on the characteristics and attributes of an embedded system.
- Develop the hardware/software co-design and firmware design using ARM Cortex M3.Instruction set.
- Analyze the need of real time operating system for embedded system applications.

Question paperpattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

TextBooks:

- 1. JosephYiu, "TheDefinitiveGuidetotheARMCortex-M3", 2ndEdition, Newnes, (Elsevier), 2010.
- ShibuKV, "IntroductiontoEmbeddedSystems", TataMcGrawHillEducationPrivateLimited, 2nd Edition.

Reference Books:

- 1. JamesK.Peckol, "Embeddedsystems-Acontemporarydesigntool", John Wiley, 2008, ISBN: 978-0-471-72180-2.
- YifengZhu, "EmbeddedSystemswithArmCortex-MMicrocontrollersinAssemblyLanguageand C", 2nd E -Man Press LLC ©2015 ISBN:09826926339780982692639.
- 3. EmbeddedrealtimesystemsbyK.V.K.KPrasad,Dreamtechpublications,2003.
- 4. Embedded Systems by Rajkamal, 2nd Edition, McGraw hill Publications, 2010.

ChoiceBasedCreditSystem	B. E. (EC / TC) n(CBCS)andOutcomeBa VI	sedEducation(OBE) SEME	STER –
MICH	ROWAVE and ANTEN	NAS	
Course Code	18EC63	CIE Marks	40
Number of Lecture Hours/Week	03+02(Tutorial)	SEE Marks	60
		Exam Hours	03
	CREDITS – 04		
 Course Learning Objectives: This course v Describe the microwave properties Describe microwave devices for sev Understandthebasicsofantennatheor Selectantennasforspecificapplication 	and its transmissionmedi veralapplications ^T Y	a	
	Module1		RBT Level
Microwave Tubes: Introduction, Reflex K of Oscillations, Mode Curve (Qualitative A Microwave Transmission Lines: Microw Systems, Transmission Line equations and Coefficient, Standing Wave and Standing W (Text 2: 0.1, 0.2, 0.3, 3.1, 3.2, 3.3, 3.5, 3.6)	nalysis only). (Text 1: 9. wave Frequencies, Micr l solutions, Reflection C Vave Ratio, Smith Chart,	1, 9.2.1) owave devices, Microwave oefficient and Transmission Single Stub matching.	L1,L2
	Module2		
Microwave Network theory: Introduction, Networks, S matrix representation of Multi- Microwave Passive Devices: Coaxial Com Waveguide Tees, Magic tees. (Text 1: 6.4.2 6.4.14, 6.4.15, 6.4.16)	-Port Networks. (Text1:) nectors and Adapters, Att	6.1, 6.2, 6.3)	L1,L2
	Module3		
Strip Lines: Introduction, Micro Strip line Strip Lines. (Text 2: 11.1, 11.2, 11.3, 11.4) Antenna Basics: Introduction, Basic An Intensity, Beam Efficiency, Directivity and Communication Link, Antenna Field Zones	tenna Parameters, Patter d Gain, Antenna Apertur	rns, Beam Area, Radiation res, Effective Height, Radio	L1,L2,L3
	Module4		
Point Sources and Arrays : Introduction Radiation Intensity, Arrays of two isotrop Sources of equal Amplitude and Spacing.(T Electric Dipoles: Introduction, Short Ele Resistance of a Short Electric Dipole, Thin	ic point sources, Linear Fext 3: 5.1 – 5.6, 5.9, 5.13 ectric Dipole, Fields of	Arrays of n Isotropic Point 3) a Short Dipole, Radiation	L1,L2,L3, L4
	Module5		
LoopandHornAntenna:Introduction,Small Antenna as a special case, Radiation resista with uniform current, Horn antennas Rectar 7.8, 7.19, 7.20) Antenna Types: The Helix geometry, He mono-filaraxialmodeHelicalAntenna,Yagi- 8.8, 9.5)	ance of loops, Directivity ngular Horn Antennas.(To elix modes, Practical De	v of Circular Loop Antennas ext 3: 7.1, 7.2, 7.4, 7.6,7.7, esign considerations for the	L1,L2,L3

Course outcomes: At the end of the course students will be able to:

- Apply Smith charts to find solutions to transmission line problems.
- Analyze passive microwave devices using S-parameters
- Evaluate various parameters and characteristics of the microwave strip lines and devices.
- Estimate radiation patterns and performance parameters of n-isotropic antennas
- Recommend various antenna configurations based on application

Question paperpattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.

Text Books:

- 1. MicrowaveEngineering-AnnapurnaDas,SisirKDas,TMH,Publication,2nd,2010.
- 2. Microwave Devices and circuits- Samuel Y Liao, PearsonEducation
- 3. Antennas and Wave Propagation- John D. Krauss, Ronald J Marhefka, Ahmad S Khan, 4th Edition, McGraw Hill Education,2013

Reference Books:

- 1. MicrowaveEngineering-DavidMPozar,JohnWileyIndiaPvt.Ltd.,3rdEdn,2008.
- 2. Microwave Engineering Sushrut Das, Oxford Higher Education, 2ndEdn,2015
- 3. AntennasandWavePropagation-HarishandSachidananda:OxfordUniversity Press,2007

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VI

	11		
	OPERATING SYSTEM		
Course Code	18EC641	CIE Marks	40
Number of Lecture Hours/Week	03	SEE Marks	60
Total Number of Lecture Hours	40 (8 Hours /Module)	Exam Hours	03
	CREDITS – 03		

Course Learning Objectives: This course will enable students to:

- Understand the services provided by an operating system.
- Explain how processes are synchronized and scheduled.
- $\bullet \quad Understand different approaches of memory management and virtual memory management.$
- Describe the structure and organization of the filesystem
- Understand interprocess communication and deadlocksituations.

Module-1	RBT Level
Introduction to Operating Systems OS, Goals of an OS, Operation of an OS, Computational Structures, Resource allocation techniques, Efficiency, System Performance and User Convenience, Classes operating System, Batchprocessing,Multiprogramming,TimeSharingSystems,RealTimeanddistributedOperating Systems(Topics from Sections 1.2, 1.3, 2.2 to 2.8 ofText).	L1,L2
Module-2	
Process Management: OS View of Processes, PCB, Fundamental State Transitions of a process, Threads, Kernel and User level Threads, Non-preemptive scheduling- FCFS and SRN, Preemptive Scheduling- RR and LCN, Scheduling in Unix and Scheduling in Linux (Topics from Sections 3.3, 3.3.1 to 3.3.4, 3.4, 3.4.1, 3.4.2 , Selected scheduling topics from 4.2 and 4.3 , 4.6, 4.7 of Text).	L1,L2,L 3
Module – 3	
Memory Management: Contiguous Memory allocation, Non-Contiguos Memory Allocation, Paging, Segmentation, Segmentation with paging, Virtual Memory Management, Demand Paging, VM handler, FIFO, LRU page replacement policies, Virtual memory in Unix and Linux(Topics from Sections 5.5 to 5.9, 6.1 to 6.3 except Optimal policy and 6.3.1, 6.7,6.8 of Text).	L1,L2,L 3
Module-4	
File Systems: File systems and IOCS, File Operations, File Organizations, Directory structures, FileProtection,InterfacebetweenFilesystemandIOCS,Allocationofdiskspace,Implementing fileaccess (Topics from Sections 7.1 to 7.8 of Text).	L1,L2
Module-5	
Message Passing and Deadlocks : Overview of Message Passing, Implementing message passing, Mailboxes, Deadlocks, Deadlocks in resource allocation, Handling deadlocks, Deadlock detection algorithm, Deadlock Prevention (Topics from Sections 10.1 to 10.3, 11.1 to 11.5 of Text).	L1,L2
 Course Outcomes: At the end of the course, the students will be able to: Explain the goals, structure, operation and types of operatingsystems. Apply scheduling techniques to find performancefactors. Explain organization of file systems andIOCS. Apply suitable techniques for contiguous and non-contiguous memoryallocation. Describe message passing, deadlock detection and preventionmethods. 	

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthe module.
- $\bullet \quad Students will have to answer 5 full questions, selecting one full question from each module.$
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

Operating Systems – A concept based approach, by Dhamdhere, TMH, 2nd edition.

Reference Books:

- $1. \quad Operating systems concepts, Silberschatz and Galvin, John Wiley India Pvt. Ltd, 5^{th} edition, 2001.$
- $2. \quad Operating system-internals and design system, William Stalling, Pearson Education, 4 the d, 2006.$
- 3. Design of operating systems, Tannanbhaum, TMH,2001.

ChoiceBasedCreditSystem	B. E. (EC / TC) n(CBCS)andOutcomeBasedF VI	Education(OBE) SEME	STER –
ARITIF	ICAL NEURAL NETWORK	KS	
Course Code	18EC642	CIE Marks	40
Number of Lecture Hours/Week	03	SEE Marks	60
Total Number of Lecture Hours	40 (8 Hours / Module)	Exam Hours	03
	CREDITS – 03		
 Course Learning Objectives: This course v Understand the basics of ANN and c AcquireknowledgeonGeneralization Understand reinforcement learning v Acquire knowledge of unsupervised 	comparison with Humanbrain. andfunctionapproximationofva using neuralnetworks		
	Module-1		RBT
Introduction : Biological Neuron – Artific Architecture : Feedforward and Feedback, Non-Linear Separable Problem. XOR Probl Learning : Learning Algorithms, Error of objective of TLNs, Perceptron Learning Alg	Convex Sets, Convex Hull an lem, Multilayer Networks. correction and Gradient Des	d Linear Separability, cent Rules, Learning	L1, L2
I	Module-2		
Supervised Learning: Perceptron learning Learning,MSEErrorsurface,SteepestDescen Application of LMS to Noise Cancell propagation Learning Algorithm, Practical	tSearch,μ-LMSapproximateto ling, Multi-layered Network	gradientdescent,	L1,L2, L3
I	Module-3		
Support Vector Machines and Radial B Learning Theory, Support Vector Machine Basis Function Regularization theory, Gen application to face recognition.	es, SVM application to Image	Classification, Radial	L1,L2, L3
I	Module-4		
Attractor Neural Networks: Associative Associative memory, Hopfield Network, ap neuralNetwork,SimulatedAnnealing,Boltzm	oplication of Hopfield Network	, Brain State in a Box	L1,L2, L3
I	Module-5		
Self-organization Feature Map: Maxi Components, GeneralizedLearningLaws, Ve Application of SOM, Growing NeuralGas.			L1,L2, L3
 Course Outcomes: At the end of the course Understandtheroleofneuralnetworksi Understand the concepts and technic neural networkmodels. Evaluate whether neural networks and Apply neural networks to particular performance. 	inengineering, artificialintellige ques of neural networks throug re appropriate to a particularap	h the study of the most i plication.	mportant

Question paperpattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.
- $\bullet \quad Students will have to answer 5 full questions, selecting one full question from each module.$
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

NeuralNetworksAClassroomApproach–SatishKumar,McGrawHillEducation(India)Pvt.Ltd,Second Edition.

Reference Books:

- 1. Introduction to Artificial Neural Systems-J.M. Zurada, Jaico Publications1994.
- 2. Artificial Neural Networks-B. Yegnanarayana, PHI, New Delhi1998.

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER -VI

DATA	STRUCTURE	USING C++
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Course Code	18EC643	IA Marks	40
Number of Lecture Hours/Week	03	Exam Marks	60
Total Number of Lecture/ Hours	40 (08 Hrs per Module)	Exam Hours	03
CREDITS – 03	3		

Course Learning Objectives: This course will enable students to

- Solve the problems using object oriented approach
- Explain fundamentals of data structures and their applications essential for programming/problemsolving
- Analyze Linear Data Structures: Stack, Queues, Lists
- Analyze Non Linear Data Structures: Trees
- Assess appropriate data structure during program development/ProblemSolving

Module-1

INTRODUCTION: C++ and itsfeatures, Data types, Variables, Operators, Expressions, Control structures, classes and Objects, Functions and parameters, function overloading, Recursion, Constructors, DestructorsandOperator overloading, Inheritance, Polymorphism, Programming examples. L1,L2

Module -2

ARRAYS AND MATRICES: Arrays, Matrices, Special matrices, Sparse matrices.

POINTERS: Pointers, Dynamic memory allocation

LINEAR LISTS: Data objects and structures, Introduction to Linear and Non Linear data structures,

Linear list data structures, Array Representation, Vector Representation, Singly Linked lists and

chains. L1, L2

Module -3

STACKS: The abstract data types, Array Representation, Linked Representation, Applications – Parsing and Evaluation of arithmetic expressions, Parenthesis Matching & Towers of Hanoi. L1, L2,L3

Module -4

QUEUES: The abstract data types, Array Representation, Linked Representation, Applications-Railroad car arrangement, Priority Queues

HASHING: Dictionaries, Linear representation, Hash table representation. L1, L2, L3

Module -5

TREES: Binary trees, Properties and representation of binary trees, Common binary tree operations, Binary tree traversal the ADT binary tree, ADT binary tree and the class linked binary tree. Binary search trees operations and implementation. Heaps, Applications-Heap Sorting L1, L2,L3

Course Outcomes: After studying this course, students will be able to:

- Acquire knowledge of Dynamic memory allocation, Various types of data structures, operations and algorithms and Sparse matrices and Hashing
- Understand non Linear data structures trees and theirapplications
- Design appropriate data structures for solving computingproblems
- Analyze the operations of Linear Data structures: Stack, Queue and LinkedList and their applications •

Text Book:

1. Data structures, Algorithms, and applications in C++, SartajSahni, Universities Press, 2ndEdition, 2005.

Reference Books:

2. Object Oriented Programming with C++, E.Balaguruswamy, TMH, 6th Edition, 2013.

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VI

ChoiceBasedCreditSystem(Cl	BCS)andOutcomeBasedEd VI	ucation(OBE) SEMES	ΓER –
DIGITAL SYSTI	EM DESIGN USING VER	ILOG	
Course Code	18EC644	CIE Marks	40
Number of Lecture Hours/Week	03	SEE Marks	60
Total Number of Lecture Hours	40 (08 Hrs per module)	Exam Hours	03
	CREDITS – 03	·	
 Course Learning Objectives: This course will Understand the concepts of VerilogLan Design the digital systems as an activit Study the design and operation of semi application specific digitalsystem. InspecthoweffectivelyIC'sareembedded application. DesignanddiagnosisofprocessorsandI/C 	iguage. y in a larger systems designc conductor memories frequer dinpackageandassembledinP	tly used in CB'sfordifferent	
Mo	odule -1		RBT Level
Introduction and Methodology: Digital Systems and Embedded Systems, Real- 1.3 to 1.5 of Text). Combinational Basics: Combinational Compe Circuits (2.3 and 2.4 of Text). Number Basics: Unsigned integers, Signed Int Numbers (3.1.1, 3.2.1, 3.3.1 and 3.4). Sequential Basics: Sequential Datapaths and C (4.3 up to 4.3.1, 4.4 up to 4.4.1 of Text).	onents and Circuits, Verificat	ion of Combinational Floating point	L1,L2, L3
Mo	odule -2		
Memories: Concepts, Memory Types, Error D	etection and Correction (Ch	ap 5 of Text).	L1,L2, L3
	dule -3		
Implementation Fabrics: Integrated Circuits, Circuit boards, Interconnection and Signal integ		es, Packaging and	L1,L2, L3
Ma	dule -4		
I/O interfacing: I/O devices, I/O controllers, P (Chap 8 of Text).	arallel Buses, Serial Transm	ission, I/O software	L1,L2, L3
Ma	dule -5		
Design Methodology: Design flow, Design op (Chap 10 of Text).	timization, Design for test, N	Vontechnical Issues	L1,L2, L3, L4
 Course outcomes: After studying this course, s Construct the combinational circuits, usin Describe how arithmetic operations car circuits that implement arithmetic opera Design a semiconductor memory for sp Design embedded systems using small processor cores. Synthesize different types of I/O contro Question paper pattern: Examination will be conducted for 100 mar 20 marks. 	gdiscretegatesandprogramm n be performed for each kind tions. becific chipdesign. microcontrollers, larger CPU bllers that are used in embedo	of code, and also comb Js/DSPs, or hard or soft dedsystem.	
 Each full question can have a maximum 	n of 1 subquestions		

- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad There will be 2 full questions from each module covering all the topics of the module.$

- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

Peter J. Ashenden, "Digital Design: An Embedded Systems Approach Using VERILOG", Elesvier, 2010.

Reference Books:

- 1. Ming-BoLin, "DigitalSystemDesignsandPractices:UsingVerilogHDLandFPGAs", Wiley, 2008
- 2. Charles Roth, Lizy K. John, "ByeongKilLeeDigital Systems Design Using Verilog, Cengage", Cengage, 1stEdition.
- 3. Donald E. Thomas, Philip R. Moorby, "The Verilog Hardware Description Language", Springer, Fifth edition.
- 4. Michael D. Ciletti, "Advanced Digital Design with the Verilog HDL" Pearson (Prentice Hall), Second edition.

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VI

	NANOELECTRONICS		
Course Code	18EC645	CIE Marks	40
Number of Lecture Hours/Week	03	SEE Marks	60
Total Number of Lecture Hours	40 (8 Hours / Module)	Exam Hours	03
	CREDITS – 03	•	

Course Learning Objectives: This course will enable students to:

- Enhancebasicengineeringscienceand technicalknowledgeofNanoelectronics.
- Explainbasicsoftop-downandbottom-upfabricationprocess, devices and systems.
- Describe technologies involved in modern day electronic devices.
- Knowvariousnanostructuresofcarbon and the nature of the carbon bonditself.
- Learn the photo physical properties of sensor used in generating asignal.

Module-1	RBT Level
Introduction: Overview of nanoscience and engineering. Development milestones in microfabricationandelectronicindustry. Moore's lawand continued miniaturization, Classification of Nanostructures, Electronic properties of atoms and solids: Isolated atom, Bonding between atoms, Giant molecular solids, Free electron models and energy bands, crystalline solids, Periodicity of crystal lattices, Electronic conduction, effects of nanometer length scale, Fabrication methods: Top down processes, Bottom up processes methods for templating the growth of nanomaterials, ordering of nanosystems (Text 1).	L1, L2
Module-2	
Characterization: Classification, Microscopic techniques, Field ion microscopy,scanning probe techniques, diffraction techniques: bulk and surface diffraction techniques (Text 1). Inorganic semiconductor nanostructures: overview of semiconductor physics. Quantum confinementinsemiconductornanostructures:quantumwells,quantumwires,quantumdots,super-lattices, band offsets, electronic density of states (Text1).	L1, L2
Module-3	
Fabrication techniques: requirements of ideal semiconductor, epitaxial growth of quantum wells, lithography and etching, cleaved-edge over growth, growth of vicinal substrates, strain induced dots and wires, electrostatically induced dots and wires, Quantum well width fluctuations, thermally annealed quantum wells, semiconductor nanocrystals, collidal quantum dots, self-assembly techniques.(Text 1). Physical processes: modulation doping, quantum hall effect, resonant tunneling, charging effects, ballistic carrier transport, Inter band absorption, intraband absorption, Light emission processes, phonon bottleneck, quantum confined stark effect, nonlinear effects, coherence and dephasing, characterization of semiconductor nanostructures: optical electrical and structural (Text 1). Module-4	L1, L2
Carbon Nanostructures: Carbon molecules, Carbon Clusters, Carbon Nanotubes, application of	
Carbon Nanotubes. (Text 2)	L1, L2
Module-5	
Nanosensors: Introduction, WhatisSensorandNanosensors?, WhatmakesthemPossible?, Order From Chaos, Characterization, Perception, NanosensorsBased On Quantum Size Effects, Electrochemical Sensors, Sensors Based On Physical Properties, Nanobiosensors, Smart dust Sensor for the future. (Text3) Applications: Injection lasers, quantum cascade lasers, single-photon sources, biological tagging, optical memories, coulomb blockade devices, photonic structures, QWIP's, NEMS, MEMS (Text 1).	L1, L2
 Course Outcomes: After studying this course, students will be able to: Understand the principles behind Nanoscience engineering andNanoelectronics. Know the effect of particles size on mechanical, thermal, optical and electrical properties of nanomaterials. 	

• Knowthepropertiesofcarbonandcarbonnanotubesanditsapplications.

- Knowthepropertiesusedforsensingandtheuseofsmartdustsensors.
- Apply the knowledge to prepare and characterizenanomaterials.
- Analyse the process flow required to fabricate state-of-the-art transistortechnology.

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Books:

- 1. Ed Robert Kelsall, Ian Hamley, Mark Geoghegan, "Nanoscale Science and Technology", John Wiley, 2007.
- 2. CharlesPPoole, Jr, Frank JOwens, "Introduction to Nanotechnology",

John Wiley, Copyright 2006, Reprint2011.

3. TPradeep, "Nano: Theessentials-Understanding Nanoscience and Nanotechnology", TMH.

Reference Book:

1. Ed William A Goddard III, Donald W Brenner, Sergey E. Lyshevski, Gerald J Iafrate, "Hand Book of Nanoscience Engineering and Technology", CRC press, 2003.

DVTHON	SEMEST		
PTITION A	APPLICATIO	N PROGRAMMING	ч F
Subject Code	18EC 646	IA Marks	20
Number of Lecture Hours/Week	3	Exam Marks	80
Total Number of Lecture Hours	40	Exam Hours	03
C	REDITS – 03	·	
Course Learning Objectives: This course	urse will enable	students to	
• Learn Syntax and Semantics and creaters	ate Functionsin	Python.	
• Handle Strings and Files inPython.			
UnderstandLists,DictionariesandReg	-	· · · · · · · · · · · · · · · · · · ·	
• ImplementObjectOrientedProgramm	•	•	
• Build Web Services, Network and	Database Progr	ams inPython.	
Module – 1			Teaching
			Hours
Why should you learn to write programs, Va	riables, express	ions and statements,	8 Hours
Conditional execution, Functions	-		
Module – 2			
teration, Strings, Files			8 Hours
Module – 3			
Lists, Dictionaries, Tuples, Regular Expressi	ons		8 Hours
Module – 4			
Classes and objects, Classes and functions, C	Classes and meth	nods	8 Hours
Module – 5			
Networked programs, Using Web Services, U	Using databases	and SOL	8 Hours
	-		0 HOULD
Course outcomes: The students should			
• ExaminePythonsyntaxandsemanticsa			ntrolandfunctions.
DemonstrateproficiencyinhandlingSt	• •		- Lista Distignation on due
 Create, run and manipulate Python P RegularExpressions. 	rograms using o	core data structures m	ke Lists, Dictionaries and us
 InterprettheconceptsofObject-Oriente 	edProgramming	asused in Python	
Implementexemplaryapplicationsrela			vicesandDatabasesin
Python.		- ogramming, (* eozer	
Question paper pattern:			
• The question paper will have TENqu	estions.		
TherewillbeTWOquestionsfromeach			
Eachquestionwillhavequestionscover			
• ThestudentswillhavetoanswerFIVEfu	allquestions, sele	ectingONEfullquestio	nfromeachmodule.
Fext Books:			
			st

Independent Publishing Platform, 2016 (Chapters 1 – 13,15).
Allen B. Downey, "Think Python: How to Think Like a Computer Scientist", 2ndEdition, Green Tea Press, 2015 (Chapters15,16,17)

References:

1. Mark Lutz, "Programming Python", 4th Edition, O'Reilly Media, 2011.ISBN-13: 978-9350232873.

2. Wesley J Chun, "Core Python Applications Programming", 3rd Edition, Pearson Education India, 2015. ISBN-13:978-9332555365.

3. Reema Thareja, "Python Programming using problem solving approach", Oxford university press,2017

OPEN ELECTIVES-A OFFERED BY EC/TC BOARD

	B. E. EC/TE		
ChoiceBasedCreditSystem(C	CBCS)andOutcomeBasedE	Education(OBE) SEMES	FER –
SIG	VI SNAL PROCESSING		
Course Code	18EC651	CIE Marks	40
Number of Lecture Hours/Week	03	SEE Marks	60
Total Number of Lecture Hours	40(8Hours/Module)	Exam Hours	03
	CREDITS – 03		
 Course objective: This course will enable stu Understand, represent and classify continger representation of LTI systems. 	nuoustimeanddiscretetimesi		
 Ability to represent continuous time s domain and the frequencydomain Understandthepropertiesofanalogfilter Understand and apply sampling theory from discrete time to continuous time 	s,andhavetheabilitytodesign em and convert a signal fror	Butterworthfilters n continuous time to discre	
• Able to represent the discrete time sig			
• Able to design FIR and IIR filters to n	neet givenspecifications		<u> </u>
Ν	Iodule-1		RBT Level
Signal Definition, Signal Classification, Syste	m definition System classif	ication for both	
continuous time and discrete time. Definition			L1, L2
	Iodule-2	,	
Introduction to Fourier Transform, Fourier Se		ransform to Fourier	L1, L2
Transform, Frequency response of continuous			1.1, 1.2
	Iodule-3	filtons Design and	1110
Frequency response of ideal analog filters, Salimplementation of Analog Butterworth filters			L1,L2, L3
		(Chapter 0)	1.5
	Iodule-4		
Sampling Theorem- Statement and proof, converting the analog signal to a digital signal. Practical sampling. The Discrete Fourier Transform, Properties of DFT. Comparing the frequency response of analog and digital systems. (FFT not included) (Chapter 3, 4)			L1,L2, L3
	Iodule-5		
Definition of FIR and IIR filters. Frequency re Transforming the Analog Butterworth filter techniques, to meet given specifications. Des the frequency sampling technique to meet give the desired filter frequency response (Chapter)	to the Digital IIR Filter ign of FIR Filters using the en specifications Comparing	using suitable mapping Window technique, and	L1,L2, L3
 Course Outcomes: After studying this course Understandandexplaincontinuoustime domain Applytheconceptsofsignalsandsystem. Analysethegivensystemandclassifythe Design analog/digital filters to meet g Design and implement the analog filter 	anddiscretetimesignalsands stoobtainthedesiredparamete system/arriveatasuitablecon ivenspecifications	er/representation clusion	-

- Design and implement the analog filter using components/ suitable simulationtools (*assignment component*)
- Designandimplementthedigitalfilter(FIR/IIR)usingsuitablesimulationtools, and record the input and output of the filter for the given audio signal (assignment component)

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad The rewill be 2 full questions from each module covering all the topics of the module.$
- $\bullet \quad Students will have to answer 5 full questions, selecting one full question from each module.$
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Book:

'Signals and Systems', by Simon Haykin and Barry Van Veen, Wiley.

References:

- 1. 'Theory and Application of Digital Signal Processing', Rabiner and Gold
- 2. 'Signals and Systems', Schaum's Outlineseries
- 3. 'Digital Signal Processing', Schaum's Outlineseries

	SEMESTER –VI		
SENSOR	S and SIGNAL CONDITION	ING	
Course Code	18EC652	CIE Marks	40
Number of Lecture Hours/Week	03	SEE marks	60
Total Number of Lecture Hours	40 (08 Hrs/module)	Exam Hours	03
	CREDITS – 03		
 Course Learning Objectives: This course Understand various technologies a Acquire knowledge about types of Get acquainted about material proposed 	ssociated in manufacturing ofse sensors used in modern digitals		
	Module 1		RBT Level
Introduction to sensor bases measureme			
General concepts and terminology, sense	1 1		
microsensortechnology,magnetoresistors,l	ightdependentresistors, resistivel	nygrometers,resistive	L1, L2
gas sensors, liquid conductivitysensors			
(Selected topics from ch.1 & 2 of Text)	Module 2		
Reactance Variation and Electromagnet		a Inductivo Concora	
Electromagnetic Sensors. Signal Conditioning for Reactance Varia CarrierAmplifiers,CoherentDetection,Spec	ation Sensors-Problems and Al cificSignalConditionersforCapac	ternatives, ac Bridges	L1, L2
Resolver-to-Digital and Digital-to-Resolve			
	Module 3	1	
Self-generating Sensors-Thermoelectric s		yroelectric sensors,	L2,L3
photovoltaic sensors, electrochemical sens	Module 4		,
Digital and intelligent sensors-position		hand on quarter	
resonators, SAW sensors, Vibrating wire s meters.	train gages, vibrating cylinder s		L2,L3
	Module 5		
Sensors based on semiconductor juncti magneto diodes and magneto transistors MOSFET transistors, charge- coupled sens sensors.	, photodiodes and phototransi	stors, sensors based on	L2,L3
Course Outcomes: After studying this con	urse, students will be able to:		
• Appreciate various types of sensor			
• Use sensors specific to the end use			
• Design systems integrated withsen			
 Question paper pattern: Examination will be conducted for 10 20 marks. Each full question can have a max There will be 2 full questions from eac Students will have to answer 5 full que 	imum of 4 subquestions. hmodulecoveringallthetopicsoft	hemodule. fromeachmodule.	of

B. E. (EC / TC) ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VI EMBEDDED SYSTEMS LAB			
Course Code	18ECL66	CIE Marks	40
Number of Lecture Hours/Week	02Hr Tutorial(Instructions) + 02 Hours Laboratory	SEE Marks	60
RBT Levels	L1, L2, L3	Exam Hours	03
	CDEDITS 02		

CREDITS – 02

Course Learning Objectives: This course will enable students to:

- UnderstandtheinstructionsetofARMCortexM3,a32bitmicrocontrollerandthesoftwaretool required for programming in Assembly and Clanguage.
- ProgramARMCortexM3usingthevariousinstructionsinassemblylevellanguagefordifferent applications.
- Interface external devices and I/O with ARM CortexM3.
- DevelopClanguageprograms and library functions for embedded system applications.

Laboratory Experiments

Conduct the following experiments on an ARMCORTEXM3 evaluation board to learn ALP and using evaluation version of Embedded 'C' & Keil uV ision-4tool/compiler.

PART A:

- 1. ALP to multiply two 16 bit binarynumbers.
- 2. ALP to find the sum of first 10 integernumbers.
- 3. ALP to find the number of 0's and 1's in a 32 bitdata
- 4. ALP to find determine whether the given 16 bit is even orodd
- 5. ALP to write data toRAM

PART B:

- 6. Display "Hello world" message using internalUART
- 7. Interface and Control the speed of a DCMotor.
- 8. InterfaceaSteppermotorandrotateitin clockwiseandanti-clockwisedirection.
- 9. Interface a DAC and generate Triangular and Squarewaveforms.
- 10. Interface a 4x4 keyboard and display the key code on anLCD.
- 11. Demonstrate the use of an external interrupt to toggle an LEDOn/Off.
- 12. DisplaytheHexdigits0 toFona7-segmentLEDinterface, with anappropriatedelay.
- 13. Measure Ambient temperature using a sensor and SPI ADCIC.

Course outcomes: After studying this course, students will be able to:

- Apply the instruction set of 32 bit microcontroller ARM Cortex M3, and the software tool required for programming in Assembly and C language.
- Develop assembly language programs using ARM Cortex M3 for different applications
- Develop C language programs to interface external devices and I/O with ARM Cortex M3.
- Develop C language programs for embedded system applications.
- Develop C language programs which makes use of library functions for embedded system applications.

Conduction of Practical Examination:

- $\bullet \quad One Question from PARTA and one Question from PARTB to be asked in the examination.$
- $\bullet \quad Strictly follow the instructions as printed on the cover page of an swerscript for break up of marks.$
- $\bullet \quad Change of experiment is allowed only on cean dMarks all otted to the procedure part to be made zero.$

B. E. ECE ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VI

.

	COMMUNICATION LAB		
Course Code	18ECL67	CIE Marks	40
Number of Lecture Hours/Week	02Hr Tutorial(Instructions) + 02 Hours Laboratory	SEE Marks	60
RBT Levels	L1, L2, L3	Exam Hours	03
	CREDITS – 02		
Course Learning Objectives: This	course will enable students to:		

- Design and test the communication circuits for different analog modulationschemes.
- Design and demonstrate the digital modulation techniques
- Demonstrate and measure the wave propagation in microstripantennas
- Characteristics of microstrip devices and measurement of itsparameters.
- Understandtheprobabilityoferrorcomputationsofcoherentdigitalmodulationschemes.

Laboratory Experiments

PART-A: Experiments No. 1 to 5 has to be performed using discrete components.

- 1. Amplitude Modulation andDemodulation: i) Standard AM, ii)DSBSC (LM741 and LF398 ICs can be used)
- 2. Frequency modulation and demodulation (IC 8038/2206 can beused)
- 3. Pulse sampling, flat top sampling and reconstruction
- 4. Time Division Multiplexing and Demultiplexing of two bandlimited signals.
- 5. FSK and PSK generation anddetection
- 6. Measurementoffrequency, guidewavelength, power, VSWR and attenuation in microwavetest bench.
- 7. Obtain the Radiation Pattern and Measurement of directivity and gain of microstrip dipole and Yagi antennas.
- 8. Determination of
 - a. Coupling and isolation characteristics of microstrip directionalcoupler.
 - b. Resonance characteristics of microstrip ring resonator and computation of dielectric constant of thesubstrate.
 - c. Power division and isolation of microstrip powerdivider.

PART-B: Simulation Experiments using SCILAB/MATLAB/Simulink or LabVIEW

- 1. Simulate NRZ, RZ, half-sinusoid and raised cosine pulses and generate eye diagram for binary polar signaling.
- 2. Pulse code modulation and demodulationsystem.
- 3. Computations of the Probability of bit error for coherent binary ASK, FSK and PSK for an AWGN Channel and Compare them with their Performancecurves.
- $4. \ Digital Modulation Schemesi) DPSKT ransmitter and receiver, ii) QPSKT ransmitter and Receiver.$

Course Outcomes: On the completion of this laboratory course, the students will be able to:

- Make use of the characteristics and response of microwave devices
- Utilize the characteristics of micros trip antennas and measurement of its parameters.
- Construct the digital modulation schemes with the display of waveforms and computation of performance parameters
- Make use of the characteristics of Optical Fibre Communication and calculate the parameters associated with it.
- Model different digital communication concepts using simulation

Conduct of Practical Examination:

- All laboratory experiments are to be considered for practicalexamination.
- Forexamination on equestion from **PART-A** and on equestion from **PART-B** or only on equestion from **PART-B** experiments based on the complexity, to be set.
- Students are allowed to pick one experiment from thelot.
- Strictlyfollowtheinstructionsasprintedonthecoverpageofanswerscriptforbreakupofmarks.
- $\bullet \quad Change of experiment is allowed only on cean dMarks all otted to the procedure part to be made zero.$

K.S.INSTITUTE OF TECHNOLOGY, BANGALORE

(AFFLIATED TO VISVESVARAYA TECHNOLOGICAL UNIVERSITY, BELGAUM) DEPARTMENT OF ELECTRONICS & COMMUNICATION ENGG. WIRELESS AND CELLULAR COMMUNICATION VIII

Course Title: WIRELESS AND CELLULAR COMMUNICATIONCourse Code : 18EC81Credits:03L-T-P :4-0-0Contact Hours/Week: 04Total Hours:50Exam. Marks:100IA Marks :30Exam. Hours : 03IA Marks :30

Course Learning Objectives: This course will enable students to:	
 Understandtheconceptsofpropagationoverwirelesschannelsfromaphysicsstandpoint Application of Communication theory both Physical and networking to understand GSN handle mobiletelephony ApplicationofCommunicationtheorybothPhysicalandnetworkingtounderstandCDMAsys handle mobiletelephony. ApplicationofCommunicationtheorybothPhysicalandnetworkingtounderstandLTE-4Gsy 	temsthat
Module-1	RBT Leve
Mobile Radio Propagation –Large Scale Path Loss - Free Space Propagation Model, Relating Power to Electric Field,Three Basic Propagation Mechanisms – Reflection (Ground Reflection) , Diffraction,Scattering, Practical Link Budget, (Text 1 - 2.2 and Ref1 - Chapter 4).Fading and Multipath – Broadband wireless channel, Delay Spread and CoherenceBandwidth, Doppler Spread and Coherence Time, Angular spread and Coherence Distance(Text 1 - 2.4) ,Statistical Channel Model of a Broadband Fading Channel(Text 1 - 2.5.1)The Cellular Concept – Cellular Concept , Analysis of Cellular Systems, Sectoring (Text 1-2.3)Module-2	L1, L2
Wiodule-2	
GSM and TDMA Technology GSM System overview – Introduction, GSM Network and System Architecture, GSM Channel Concept. GSM System Operations – GSM Identities, System Operations –Traffic cases, GSM Infrastructure Communications (Um Interface) (Text 2, Part1 and Part 2 of Chapter 5)	L1,L2,L3
Module-3	
CDMA Technology CDMA System Overview – Introduction, CDMA Network and System Architecture CDMABasics–CDMAChannelConcepts,CDMASystem(Layer3)operations,3GCDMA (Text 2- Part 1, Part2 and Part 3 of Chapter6)	L1,L2,L3
Module-4	r
LTE – 4G Key Enablers for LTE 4G – OFDM, SC-FDE, SC-FDMA, Channel Dependant Multiuser Resource Scheduling, Multi-Antenna Techniques, Flat IP Architecture, LTE Network Architecture. (Text 1, Sec 1.4) Multi-Carrier Modulation – Multicarrier concepts, OFDM Basics, OFDM in LTE, Timing andFrequencySynchronization,PeaktoAverageRation,SC-FrequencyDomainEqualization, Computational Complexity Advantage of OFDM andSC-FDE. (Text 1, Sec 3.1 – 3.7)	L1,L2,L3
Module-5	1

LTE - 4G OFDMA and SC-FDMA – Multiple Access for OFDM Systems, OFDMA, SCFDMA, Multiuser Diversity and Opportunistic Scheduling, OFDMA and SC-FDMA in LTE, OFDMA system Design Considerations. (Text 1, Sec 4.1 – 4.6) The LTE Standard – Introduction to LTE and Hierarchical Channel Structure of LTE, Downlink OFDMA Radio Resources, Uplink SC-FDMA Radio Resources. (Text 1, Sec 6.1 – 6.4)	L1, L2,L3
 Course Outcomes: After studying this course, students will be able to: Make use of the system architecture and the functional standard specified in LTE 4G. 	_

- Identify the role of the layer of LTE radio interface protocols and EPS Data convergence protocols to set up, reconfigure and release data and voice from users.
- Utilize the UTRAN and EPS handling processes from set up to release including mobility management for a variety of data call scenarios.
- Identify the difference between uplink, down link and the physical layer procedures that provide the services to upper layers.

• Utilize the Performance of resource management and packet data processing and transport algorithms.

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.
- Each full question can have a maximum of 4 subquestions.
- Therewillbe2fullquestionsfromeachmodulecoveringallthetopicsofthemodule.
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreducedto60 marksasSEEmarksis60.

Text Books:

- 1. "Fundamentals of LTE" Arunabha Ghosh, Jan Zhang, Jefferey Andrews, Riaz Mohammed, Pearson education (Formerly Prentice Hall, Communications Engg and Emerging Technologies), ISBN-13:978-0-13-703311-9.
- 2. "IntroductiontoWirelessTelecommunicationsSystemsandNetworks",GaryMullet,First Edition, Cengage Learning India Pvt Ltd., 2006, ISBN 13: 978-81-315-0559-5.

Reference Books:

- 1. "Wireless Communications: Principles and Practice" Theodore Rappaport, 2nd Edition, PrenticeHallCommunicationsEngineeringandEmergingTechnologiesSeries,2002,ISBN0- 13-042232-0.
- 2. LTEforUMTSEvolutiontoLTE-Advanced'HarriHolmaandAnttiToskala,SecondEdition- 2011, John Wiley & Sons, Ltd. Print ISBN: 9780470660003.2

	Choic	eBasedCreditSystem(CB VI	II		
		NETWO	RK SECURITY		
	ct Code		18EC821	CIE Marks	40
Numb	er of Lecture l	Hours/Week	3	SEE Marks	60
Total	Number	of LectureHours	40 (08 Hours / Module)	Exam Hours	03
Cours	e Learning Ob	jectives: This course will	CREDITS – 03 enable students to:		
•	Describe netw	vork security services and ransport Level Security an	nechanisms.		
•		Security concerns in Intern	•		
•		Intruders, Intrusion detect	•	ware	
٠		Firewalls, Firewall charac			
		Modu		0	RBT Level
	1	s and Computer Security: N		rity Approaches,	L1, L2
Princip	ples of Security	Types of Attacks. (Chapt			11, 12
			Module-2		
-		rity: Web Security Conside PS, Secure Shell (SSH)(Ch		s Layer, Transport	L1,L2
		s, secure shell (ssli)(Ch	apter15- Text1)		21,22
J -		s, secure shell (ssh)(Ch	Module-3		
IP Sec Securi	urity: Overview ty Associations	w of IP Security (IPSec),I s (SA), Authentication He exchange. (Chapter19-Tex	Module-3 P Security Architecture eader (AH), Encapsula	-	L1,L2
IP Sec Securit (ESP),	urity: Overview ty Associations Internet Key E	w of IP Security (IPSec),I s (SA), Authentication H axchange. (Chapter19-Tex	Module-3 P Security Architecture eader (AH), Encapsula xt1) Module-4	-	
IP Sec Securit (ESP),	urity: Overview ty Associations Internet Key E	w of IP Security (IPSec),I s (SA), Authentication H	Module-3 P Security Architecture eader (AH), Encapsula xt1) Module-4	-	
IP Sec Securi (ESP), Intrude	urity: Overview ty Associations Internet Key E ers, Intrusion D	w of IP Security (IPSec),I s (SA), Authentication He xchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela	Module-3 P Security Architecture eader (AH), Encapsula (t1) Module-4 1)	-	
IP Sec Securi (ESP), Intrude	urity: Overview ty Associations Internet Key E ers, Intrusion D	w of IP Security (IPSec),I s (SA), Authentication He xchange. (Chapter19-Tex etection.(Chapter20-Text	Module-3 P Security Architecture eader (AH), Encapsula (t1) Module-4 1)	-	L1,L2
IP Sec Securit (ESP), Intrude MALI Counte	urity: Overview ty Associations Internet Key E ers, Intrusion D CIOUS SOFT ermeasures, (C I valls: The Need	w of IP Security (IPSec),I s (SA), Authentication He exchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha	Module-3 P Security Architecture eader (AH), Encapsula ext1) Module-4 1) ted Threats, Virus Module-5 uracteristics, Types of F	ating Security Payload	L1,L2
IP Sec Securit (ESP), Intrude MALI Counte Firew Biasin	eurity: Overview ty Associations Internet Key E ers, Intrusion D CCIOUS SOFT ermeasures, (C I valls: The Need ng, Firewall loc	w of IP Security (IPSec),I s (SA), Authentication Ho xchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha cationandconfiguration (Module-3 P Security Architecture eader (AH), Encapsula (AH), Encapsula	irewalls, Firewall	L1,L2 L1,L2
IP Sec Securit (ESP), Intrude MALI Counte Firew Biasin	urity: Overview ty Associations Internet Key E ers, Intrusion D CIOUS SOFT ermeasures, (CI valls: The Need ng, Firewall loc se Outcomes: Explain netwo Understand th	w of IP Security (IPSec),I s (SA), Authentication He exchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha cationandconfiguration (After studying this course, ork security services and m the conceptof Transport Lev	Module-3 P Security Architecture eader (AH), Encapsula ext1) Module-4 1) ted Threats, Virus Module-5 practeristics, Types of F Chapter22-Text1) students will be able to nechanisms and explain rel Security and Secure	irewalls, Firewall	L1,L2 L1,L2
IP Sec Securif (ESP), Intrude MALI Counte Firew Biasin Cour	urity: Overview ty Associations Internet Key E ers, Intrusion D CCIOUS SOFT ermeasures, (CI valls: The Need ng, Firewall loc se Outcomes: Explain netwo Understand th Explain Secur Explain Intru	w of IP Security (IPSec),I s (SA), Authentication Ho exchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha eationandconfiguration (After studying this course, ork security services and m	Module-3 P Security Architecture eader (AH), Encapsula (AH), E	irewalls, Firewall c: securityconcepts Socket Layer.	L1,L2 L1,L2
IP Sec Securif (ESP), Intrude MALI Counte Firew Biasin Cour	urity: Overview ty Associations Internet Key E ers, Intrusion D CIOUS SOFT ermeasures, (Cl valls: The Need ng, Firewall loc se Outcomes: Explain netwo Understand th Explain Secur Explain Intrue Describe Fire	w of IP Security (IPSec),I s (SA), Authentication He exchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha ationandconfiguration (After studying this course, ork security services and m te conceptof Transport Lev rity concerns in Internet Pr ders, Intrusion detection an walls, Firewall Characteris	Module-3 P Security Architecture eader (AH), Encapsula (AH), E	irewalls, Firewall c: securityconcepts Socket Layer.	L1,L2 L1,L2
IP Sec Securit (ESP), Intrude MALI Counte Firew Biasin Court • • • • • • • • • • • • •	aurity: Overview ty Associations Internet Key E ers, Intrusion D CIOUS SOFT ermeasures, (CI valls: The Need ng, Firewall loc se Outcomes: Explain netwo Understand th Explain Secur Explain Intrue Describe Fire ion paper patte xamination will ach full question	w of IP Security (IPSec),I s (SA), Authentication He exchange. (Chapter19-Tex etection.(Chapter20-Text WARE: Viruses and Rela hapter21-Text1) for firewalls, Firewall Cha ationandconfiguration (After studying this course, ork security services and m te conceptof Transport Lev rity concerns in Internet Pr ders, Intrusion detection an walls, Firewall Characteris	Module-3 P Security Architecture eader (AH), Encapsula ct1) Module-4 1) ted Threats, Virus Module-5 tracteristics, Types of F Chapter22-Text1) students will be able to vechanisms and explain vel Security and Secure otocolsecurity ud MaliciousSoftware stuces, Biasing andConfig withquestionpapercontaid 4 subquestions.	ating Security Payload irewalls, Firewall o: securityconcepts Socket Layer. guration	L1,L2 L1,L2 L1, L2

TEXT BOOKS:

- 1. CryptographyandNetworkSecurityPrinciplesandPracticel,PearsonEducationInc.,William Stallings, 5th Edition, 2014, ISBN: 978-81-317-6166-3.
- 2. Cryptography and Network Security, Atul Kahate, TMH, 2003.

REFERENCE BOOKS:

1. Cryptography and Network Security, Behrouz A. Forouzan, TMH, 2007.

		VIII TROMECHANICAL S	YSTEMS	
Course Code		18EC822	CIE Marks	40
Number of Lecture Hou	rs/Week	3	SEE Marks	60
Total Number of	LectureHours	40 (08 Hours / Module) CREDITS – 03	Exam Hours	03
Working principleDevelop mathemaKnow methods to	iew of microsystem es of several MEMS atical and analytical fabricate MEMSde on areas where MEM	s, their fabrication and ap devices. models of MEMSdevices	-	RBT Level
Overview of MEMS a		MEMS and Microsystem	n, Typical MEMS and	KD1 Level
Microsystems Products,	Evolution of Micro	fabrication, Microsystems Ainiaturization. Application	and Microelectronics,	L1, L2
		Module-2		
with Microactuators, Mic	croaccelerometers, I Microsystems Des	oduction, Microsensors, M Microfluidics. ign and Fabrication: Intr		L1,L2
Theory of Matter and Inte	r-molecular Forces,	Plasma Physics, Electroc		
Theory of Matter and Inte	r-molecular Forces,	Plasma Physics, Electroc Module-3		
Engineering Mechanics	s for Microsystems ion,Thermomechan	Module-3 s Design: Introduction, S ics,FractureMechanics,Th	hemistry. tatic Bending of Thin	L1,L2
Engineering Mechanics Plates,MechanicalVibrat	s for Microsystems ion,Thermomechan	Module-3 s Design: Introduction, S ics,FractureMechanics,Th	hemistry. tatic Bending of Thin	L1,L2
Engineering Mechanics Plates, Mechanical Vibrat Overview on Finite Elem Scaling Laws in Miniatu	s for Microsystems ion,Thermomechan nent StressAnalysis. rization: Introducti	Module-3 s Design: Introduction, S ics,FractureMechanics,Th Module-4 on, Scalingin Geometry, S aling in Fluid Mechanics,	hemistry. tatic Bending of Thin inFilmMechanics, Scaling in Rigid-Body	L1,L2
Engineering Mechanics Plates, Mechanical Vibrat Overview on Finite Elem Scaling Laws in Miniatu Dynamics, Scaling in Elec	s for Microsystems ion,Thermomechan nent StressAnalysis. rization: Introducti	Module-3 s Design: Introduction, S ics,FractureMechanics,Th Module-4 on, Scalingin Geometry, S	hemistry. tatic Bending of Thin inFilmMechanics, Scaling in Rigid-Body	
Engineering Mechanics Plates, Mechanical Vibrat Overview on Finite Elem Scaling Laws in Miniatu Dynamics, Scaling in Eleo Transfer.	s for Microsystems ion,Thermomechan nent StressAnalysis. rization: Introducti ctrostatic Forces, Sc facturing:Introduct	Module-3 s Design: Introduction, S ics,FractureMechanics,Th Module-4 on, Scalingin Geometry, S aling in Fluid Mechanics,	hemistry. tatic Bending of Thin inFilmMechanics, Scaling in Rigid-Body Scaling in Heat ring,Surface	
Engineering Mechanics Plates,MechanicalVibrat Overview on Finite Elem Scaling Laws in Miniatu Dynamics, Scaling in Elec Transfer. OverviewofMicromanu Micromachining, TheLIC Course Outcomes: Afte Appreciate the tec Understand design AnalyzetheMEMS	s for Microsystems ion, Thermomechan nent StressAnalysis. rization: Introducti ctrostatic Forces, Sc facturing:Introduct GAProcess, Sum r studying this cour chnologies related to n and fabrication pr	Module-3 s Design: Introduction, S ics,FractureMechanics,Th Module-4 on, Scalingin Geometry, S aling in Fluid Mechanics, Module-5 tion,BulkMicromanufactur mary on Micromanufactur se, students will be able to Micro Electro Mechanic ocesses involved with ME psuitablemathematicalmod	hemistry. tatic Bending of Thin inFilmMechanics, Scaling in Rigid-Body Scaling in Heat ring,Surface ing. o: alSystems. MSDevices.	L1,L2

Tai-RanHsu,MEMSandMicrosystems:Design,ManufactureandNanoscaleEngineering,2ndEd, Wiley.

Reference Books:

- 1. HansH.Gatzen,VolkerSaile,JurgLeuthold,MicroandNanoFabrication:ToolsandProcesses, Springer,2015.
- 2. DilipKumarBhattacharya,BrajeshKumarKaushik,MicroelectromechanicalSystems(MEMS), Cenage Learning.

	II			
	DAR ENGINEERING	CIE Maslar	40	
Course Code Number of Lecture Hours/Week	18EC823 3	CIE Marks SEE Marks	40 60	
Total Number of LectureHours	40 (08 Hours / Module)	Exam Hours	03	
	CREDITS – 03			
 Course Learning Objectives: This course wil Understand the Radar fundamentals and Understandvarioustechnologiesinvolved Learn various radars like MTI, Doppler 	l analyze the radarsignal linthedesignofradartrans	mittersandreceivers.		
Mod	lule-1]	RBT Leve
BasicsofRadar: Introduction,MaximumUnambig respecttopulsewaveform-PRF,PRI,DutyCycle,J Power. Simple form of the Radar Equation, Frequencies,ApplicationsofRadar,TheOriginso Text)	PeakTransmitterPower,A, Radar Block Diagran	Averagetransmitter 1 and Operation, R	with adar I	L1, L2,L3
	Module-2			
TheRadarEquation:PredictionofRange`Perfor MinimumDetectableSignal,ReceiverNoise,SNR,I Detector—FalseAlarmTimeandProbability,Pro Targets: simple targets –sphere, cone-sphere, T System Losses (qualitative treatment), Illustrat (Chapter 2 of Text, Except 2.4, 2.6, 2.8 & 2.1	ModifiedRadarRangeEqu babilityofDetection,Rad Fransmitter Power, PRF iveProblems.	ation, Enve arCrossSectionof	elope ties,	L1,L2,L3
MTIandPulseDopplerRadar:Introduction,Pri Radar, Sweep to Sweep subtraction and De Amplifier Transmitter, Delay Line Cancelers Canceler, Blind Speeds, Clutter Attenuation, I Canceler,DigitalMTIProcessing–Blindphases,I processor, Moving Target Detector- OriginalM (Chapter 3: 3.1, 3.2, 3.5, 3.6 of Text)	elay Line Canceler, M — Frequency Response MTI Improvement Facto andQChannels,DigitalM	TI Radar with – Po of Single Delay- 1 or, N- Pulse Delay-1	Line	L1,L2,L3
(Chapter 5: 5.1, 5.2, 5.5, 5.0 of Text)	Module-4			
Tracking Radar: Tracking with Radar- Types of Tracking Radar Comparison Monopulse(one-and two-coordinate Sequential Lobing, Conical Scan Tracking, Bloc Tracking in Range, Comparison of Trackers.(Cl	Systems, Monopulse Tra es), Phase Comparison M ck Diagram of Conical S	Monopulse. Ican Tracking Radar		L1,L2,L3
TheRadarAntenna:FunctionsofTheRadarAntenn ectronicallySteeredPhasedarrayAntennas.(Chag Radar Receiver: The Radar Receiver, Receive Duplexers and Receivers Protectors, Radar Dis	na,AntennaParameters,Re pter9:9.1,9.29.4, 9.5 ofT er Noise Figure, Super H	ext) Ieterodyne Receiver		L1, L2,L3
 CourseOutcomes: Attheendofthecourse, studen Understandtheradarfundamentalsandrad ExplaintheworkingprincipleofpulseDop Describe the working of various radar tr Analyzetherangeparametersofpulseradar 	arsignals. plerradars,theirapplicatio ansmitters andreceivers.			

Question paper pattern:

• Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks.

- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad The rewill be 2 full questions from each module covering all the topics of the module.$
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreducedto60 marksasSEEmarksis60.

TEXT BOOK:

Introduction to Radar Systems- Merrill I Skolink, 3e, TMH, 2001

REFERENCE BOOKS:

- 1. Radar Principles, Technology, Applications—ByronEdde, Pearson Education, 2004.
- 2. Radar Principles-Peebles. Jr, P.Z. Wiley. New York, 1998.
- 3. PrinciplesofModemRadar:BasicPrinciples–MarkA.Rkhards,JamesA.Scheer,WilliamA.HoIm. Yesdee,2013

B. E. ECE ChoiceBasedCreditSystem(CBCS)andOutcomeBasedEducation(OBE) SEMESTER – VIII

	COMMUNICATION N	ETWORKS	
Course Code	18EC824	CIE Marks	40
Number of Lecture Hours/Week	3	SEE Marks	
Total Number of Lecture Hours	40 (8 Hours / Module)	Exam Hours	03
	CREDITS – 03		
 Course Learning Objectives: This course Learn the basic principle of optical to propagation. Understand the transmission characte Studyofoptical components and its approximate the network standards in optical to principle. 	fiber communication with teristics and losses in opt plicationsinopticalcommu	icalfiber. inicationnetworks.	ght ctures alongwith
its functionalities.			
	Iodule -1		RBT Level
Optical fiber Communications: Historic of optical fiber communication, Optical fi in planar guide, Phase and group veloc Graded index fibers, Single mode fibers, C effective refractive index. Fiber Materials	ber wave guides: Ray th ity, Cylindrical fiber: M Cutoff wavelength, Mode	eory transmission, Mo Iodes, Step index fibe e field diameter,	des
	Iodule -2		
Transmission characteristics of optica Linear scattering losses, Nonlinear scatter dispersion, Intermodal dispersion: Multim Optical Fiber Connectors: Fiber alignn Mechanical splices, Fiber connectors: Cy	ing losses, Fiber bend lo node step index fiber.	ss, Dispersion, Chroma	ntic
fiberconnectors,Fibercouplers:threeandfor Circulators.(Text2)		ors, Duplex and Multi	
		ors, Duplex and Multi	ple
	Module -3 LED Structures, Light States and the structures of the structures of the structures of the structure of the structu	ors, Duplex and Multiers, OpticalIsolators	um
Circulators.(Text2) Optical sources: Light Emitting diodes: Efficiency and LED Power, Modulation.	Module -3 LED Structures, Light S Laser Diodes: Modes a locy, Resonant Frequencie notodiodes, Photo detecto ation: Error sources, Fro	ors, Duplex and Multiers, OpticalIsolators a ource Materials, Quant and Threshold conditions or noise, Detector response	um ons, L1, L2
Circulators.(Text2) Optical sources: Light Emitting diodes: Efficiency and LED Power, Modulation. Rate equation, External Quantum Efficient Photodetectors: Physical principles of Ph time. Optical Receiver: Optical Receiver Oper Receiver sensitivity, Quantum Limit.(Tex	Module -3 LED Structures, Light S Laser Diodes: Modes a locy, Resonant Frequencie notodiodes, Photo detecto ation: Error sources, Fro	ors, Duplex and Multiers, OpticalIsolators a ource Materials, Quant and Threshold conditions or noise, Detector response	um ons, L1, L2
Circulators.(Text2) Optical sources: Light Emitting diodes: Efficiency and LED Power, Modulation. Rate equation, External Quantum Efficient Photodetectors: Physical principles of Ph time. Optical Receiver: Optical Receiver Oper Receiver sensitivity, Quantum Limit.(Tex	Module -3 LED Structures, Light Sc Laser Diodes: Modes a locy, Resonant Frequencie totodiodes, Photo detector ation: Error sources, Fro tt1) Module -4 erview of WDM: Operati eterMultiplexers,Isolator rs, Diffraction Gratings. optical amplifiers,	ors, Duplex and Multi ers,OpticalIsolators a ource Materials, Quant and Threshold conditioners or noise, Detector respon nt End Amplifiers, ional Principles of WE rsandCirculators,Fiber Optical amplifiers: Ba Erbium Doped Fi	ple and um ons, L1, L2 nse

Optical Networks: Optical network evolution and concepts: Optical networking terminology, Optical network node and switching elements, Wavelength division multiplexed networks, Public telecommunication network overview. Optical network transmission modes, layers and protocols: Synchronous networks, Asynchronous transfer mode, OSI reference model, Optical transport network, Internet protocol, Wavelength routing networks: Routing and wavelength assignment, Optical switching networks: Optical circuit switched networks, packet switched networks, Multiprotocol Label Switching, Optical burst switching networks. (Text 2)	L1, L2
 Course Outcomes: At the end of the course, students will be able to: Classificationandworkingofopticalfiber withdifferentmodesofsignalpropagation. Describe the transmission characteristics and losses in optical fibercommunication. Describetheconstructionandworkingprincipleofopticalconnectors, multiplexers and amplif Describetheconstructionalfeatures and the characteristics of optical Sources and detectors. Illustrate the etworking aspects of optical fiber and describe various standards associated within the standard standards associated within the standard standard standard standard standards associated within the standard st	
 Question paper pattern: Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20 marks. Each full question can have a maximum of 4 subquestions. There will be 2 full questions from each module covering all the topics of the module. Students will have to answer 5 full questions, selecting on efull question from each module. The total marks will be proportionally reduced to 60 marks as SEE marks is 60. 	h
Text Books: 1. GerdKeiser,OpticalFiberCommunication,5 th Edition,McGrawHillEducation(India)PrivateLim ISBN:1-25-900687-5. 2. JohnMSenior,OpticalFiberCommunications,PrinciplesandPractice,3Edition,PearsonEducation ISBN:978-81-317-3266-3	
Reference Book: Joseph C Palais, Fiber Optic Communication, Pearson Education, 2005, ISBN:0130085103	

ChoiceBasedCreditSystem(0	B. E. ECE CBCS)andOutcomeBasedEd VIII	ucation(OBE) SEN	MESTER –
BIOMEDIC	CAL SIGNAL PROCESSING	, ,	
Course Code	18EC825	CIE Marks	40
Number of Lecture Hours/Week	3	SEE Marks	60
Total Number of Lecture Hours	40 (8Hours/Module) CREDITS – 03	Exam Hours	03
Course Learning Objectives: This course w Describetheorigin, properties and suitablem Know the basic signal processing techniq Acquiremathematical and computational sk Describe the basics of ECG signal compre Know the complexity of various biologic: Understand the promises, challenges of th Introduction to Biomedical Signals: The nat Biomedical Signals, Objectives and difficultie Electrocardiography: Basic electrocardiogra characteristics. Signal Conversion :Simple signal conversion biomedical signals, Signal conversion circuits Signal Averaging: Basics of signal averaging averager, software for signal averaging limita	vill enable students to: nodelsofimportantbiologicalsig ues in analysing biologicalsig cillsrelevanttothefieldofbiomec essionalgorithms. alphenomena. ne biomedicalengineering. Module -1 ture of Biomedical Signals, Ex- es in Biomedical analysis. aphy, ECG leads systems, ECC n systems, Conversion requirers (Text-1) Module -2 g, signal averaging as a digital	nals. licalsignalprocessin amples of 3 signal nents for	
averager, software for signal averaging, limita AdaptiveNoiseCancelling:Principalnoisecand sine wave model, other applications of adaptive	cellermodel,60-Hzadaptivecar	cellingusing a	L1,L2,L3
DataCompressionTechniques: Turningpointa Huffman coding, data reduction algorithms T Power spectrum estimation, Frequency domai	algorithm,AZTECalgorithm,F he Fourier transform, Correla	ion, Convolution,	L1,L2, L3
	Module -4		1
Cardiological signal processing: Basic Electrocardiography, ECG data ac characteristics (parameters and their estimat detector, Power spectrum of the ECG, H techniques, Template matching techniques, processingalgorithm,ECGinterpretation,STseg (Text -2)	ion), Analog filters, ECG an Bandpass filtering technique A QRS detection algorithm	plifier, and QRS s, Differentiation , Real-time ECG	L1,L2, L3
	Module -5		
Neurological signal processing: The brain an of brain waves, The EEG signal and its charac Correlation. Analysis of EEG channels: Detection of EEG and wave detection (Text-2)	cteristics (EEG rhythms, wave	s, and transients),	L1,L2, L3
 Course Outcomes: At the end of the course, st Possessthebasicmathematical,scientific signals. Applyclassicalandmodernfilteringandc Develop a thorough understanding on based on the standing on based on the standing on based on the standing on the standing on the standing on the standard on the standard of the standard on the standard of the standard on the standard of the stan	candcomputationalskillsnecess ompressiontechniquesforECG	andEEGsignals	ndEEG

Question paper pattern:

- Examination will be conducted for 100 marks with question paper containing 10 full questions, each of 20marks.
- Each full question can have a maximum of 4 subquestions.
- $\bullet \quad There will be 2 full questions from each module covering all the topics of the module.$
- Studentswillhavetoanswer5fullquestions, selecting one fullquestion from each module.
- Thetotalmarkswillbeproportionallyreduced to60 marksasSEEmarksis60.

Text Books:

- 1. Biomedical Digital Signal Processing- Willis J. Tompkins, PHI2001.
- 2. **BiomedicalSignalProcessingPrinciplesandTechniques-**DCReddy,McGraw-Hillpublications 2005.

Reference Book:

Biomedical Signal Analysis-Rangaraj M. Rangayyan, John Wiley & Sons 2002.